R&S®RTP HIGH-PERFORMANCE OSCILLOSCOPE



Specifications



Data Sheet Version 12 00

ROHDE&SCHWARZ

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CONTENTS

Definitions	5
Base unit	6
Vertical system	6
Horizontal system	7
Acquisition system	8
Differential signals	9
High definition mode	9
Trigger system	9
RF characteristics	11
Waveform measurements	12
Mask testing	13
Waveform math	14
Search and mark function	14
Display characteristics	15
Input and output	15
General data	17
Options	19
R&S®RTP-B1 mixed signal option	19
Vertical system	
Horizontal system	19
Acquisition system	19
Trigger system	
Waveform measurements	20
Waveform math	20
Search and mark functions	20
Display characteristics	20
R&S®RTP-B6 arbitrary waveform generator	21
Analog channels	21
8-bit pattern generator	24
R&S®RTP-B7 16 GHz differential pulse source	24
Output	24
DC characteristics	24
Time domain characteristics	25
Frequency domain characteristics	25
R&S®RTP-B21 adapter rear option slot	25
R&S®RTP-K1 I²C/SPI serial triggering and decoding	26
R&S®RTP-K2 UART/RS-232/RS-422/RS-485 serial triggering and decoding	27
R&S®RTP-K3 CAN/LIN serial triggering and decoding	28
R&S®RTP-K6 MIL-STD-1553 serial triggering and decoding	30

R&S®RTP-K7 ARINC 429 serial triggering and decoding	31
R&S®RTP-K8 Ethernet (10BASE-T/100BASE-Tx) serial triggering and decoding	31
R&S®RTP-K9 CAN-FD serial triggering and decoding	32
R&S®RTP-K11 I/Q software interface	33
R&S®RTP-K12 jitter analysis	34
R&S®RTP-K19 zone trigger	35
R&S®RTP-K21 USB 2.0 compliance test	35
R&S®RTP-K22 Ethernet compliance test (10/100/1000BASE-T)	36
R&S®RTP-K23 Ethernet compliance test (10GBASE-T)	36
R&S®RTP-K24 Ethernet compliance test (100BASE-T1)	37
R&S®RTP-K25 Ethernet compliance test (2.5G/5GBASE-T)	37
R&S®RTP-K26 MIPI D-PHY compliance test	38
R&S®RTP-K35 bus analysis	40
R&S®RTP-K37 spectrogram	41
R&S®RTP-K40 MIPI RFFE serial triggering and decoding	42
R&S®RTP-K42 MIPI D-PHY serial triggering and decoding	44
R&S®RTP-K44 MIPI M-PHY serial triggering and decoding	45
R&S®RTP-K50 Manchester and NRZ serial triggering and decoding	46
R&S®RTP-K52 8b10b serial triggering and decoding	47
R&S®RTP-K55 MDIO serial triggering and decoding	47
R&S®RTP-K57 Ethernet (100BASE-T1) serial triggering and decoding	48
R&S®RTP-K58 Ethernet (1000BASE-T1) serial triggering and decoding	49
R&S®RTP-K60 USB 1.0/1.1/2.0 serial triggering and decoding	50
R&S®RTP-K61 USB 3.1 Gen 1 serial triggering and decoding	51
R&S®RTP-K62 USB 3.1 Gen 2 serial triggering and decoding	52
R&S®RTP-K63 USB power delivery serial triggering and decoding	53
R&S®RTP-K64 USB 3.1 SSIC serial triggering and decoding	54
R&S®RTP-K65 SpaceWire serial triggering and decoding	54
R&S®RTP-K72 PCI Express 1.1/2.0 serial triggering and decoding	55
R&S®RTP-K81 PCI Express 1.1/2.0 compliance test	56
R&S®RTP-K83 PCI Express 1.1/2.0/3.0 compliance test	56
R&S®RTP-K86 Energy-efficient Ethernet compliance test (10M/100M/1GBASE-T)	57
R&S®RTP-K87 Ethernet compliance test (1000BASE-T1)	58
R&S®RTP-K88 Ethernet compliance test (MGBASE-T1)	58
R&S®RTP-K89 Ethernet compliance test (10BASE-T1)	58
R&S®RTP-K91 DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test	59
R&S®RTP-K93 DDR4/LPDDR4 signal integrity debug and compliance test	62
R&S®RTP-K99 R&S®ScopeSuite automation	64
R&S®RTP-K101 USB 3.2 transmitter compliance test	65
R&S®RTP-K121 deembedding base option	66

Version 12.00, April 2021

Proven cable/proven probe	66
R&S®RTP-K122 realtime deembedding extension	66
R&S®RTP-K130 TDR/TDT analysis	67
R&S®RTP-K133 advanced jitter analysis	68
R&S®RTP-K134 advanced jitter and noise analysis	69
R&S®RTP-K140 high speed serial pattern trigger (8 Gbps)	70
R&S®RTP-K141 high speed serial pattern trigger (16 Gbps)	70
Ordering information	71

Definitions

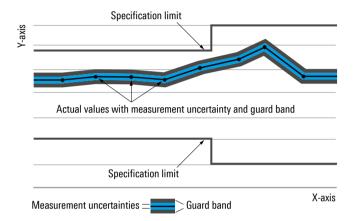
General

Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, \leq , \geq , \pm , or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bits per second (Gbps), million bits per second (Mbps), thousand bits per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, ksps and Msample/s are not SI units.

Base unit

Vertical system

Input channels		4 channels	
Input impedance	offset and position set to zero	50 Ω ± 2 %	
Analog bandwidth (–3 dB)	R&S®RTP044	≥ 4 GHz	
3	R&S®RTP064	≥ 6 GHz	
	R&S®RTP084	≥ 8 GHz	
	R&S®RTP134	≥ 13 GHz on 2 channels,	
		≥ 8 GHz on 4 channels	
	R&S®RTP164	≥ 16 GHz on 2 channels.	
		≥ 8 GHz on 4 channels	
Rise time/fall time	10 % to 90 %, calculated from 0.	43/analog bandwidth	
	R&S®RTP044	108 ps	
	R&S®RTP064	72 ps	
	R&S®RTP084	54 ps	
	R&S®RTP134	33 ps	
	R&S®RTP164	27 ps	
Vertical resolution		8 bit.	
vortical recolution		16 bit for high resolution decimation	
		(with reduction of the sampling rate),	
		16 bit for high definition mode (without reduction of the	
		sampling rate 1)	
DC gain accuracy	offset and position set to zero	Jamping late /	
20 gain accuracy	> 5 mV/div	±1.5 %	
	≤ 5 mV/div	±2 %	
Input coupling		DC	
Input sensitivity	entire analog bandwidth	2 mV/div to 1 V/div	
put consum,	supported for all input	/ /	
	sensitivities		
	in high definition mode	1 mV/div to 1 V/div	
Maximum input voltage	g as a second	±5 V	
Position range		±5 div	
Offset range	input sensitivity	1	
2go	> 100 mV/div	±5 V	
	≤ 100 mV/div	±(1.5 V – input sensitivity × 5 div)	
Offset accuracy	input sensitivity		
,	> 100 mV/div	$\pm (0.35 \% \times \text{net offset})$	
		+ 0.1 div × input sensitivity)	
	≤ 100 mV/div, net offset	±(0.35 % × net offset	
	≤ 1 V	+ 0.1 div × input sensitivity + 2 mV)	
	≤ 100 mV/div, net offset	±1 % × net offset	
	> 1 V		
	net offset = offset – position × input sensitivity		
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy ×	
	measurement noise	reading - net offset + offset accuracy)	
Channel-to-channel isolation	between channels 1-3, 1-4, 2-3,	> 60 dB (typ.)	
(each channel at same input	2-4	10 10 (
sensitivity)	between channels 1-2 and 3-4	> 40 dB (typ.)	

¹ The maximum realtime sampling rate of the high definition mode is 10 Gsample/s.

RMS noise floor (meas.)	input sensitivity	R&S®RTP044	R&S®RTP064	
(corresponding signal to noise	2 mV/div	270 μV (28.3 dB)	340 μV (26.3 dB)	
ratio at full scale (calculated))	5 mV/div	280 μV (36.0 dB)	360 μV (33.8 dB)	
	10 mV/div	410 µV (38.7 dB)	500 μV (37.0 dB)	
	20 mV/div	630 μV (41.0 dB)	750 μV (39.5 dB)	
	50 mV/div	1.4 mV (42.0 dB)	1.7 mV (40.3 dB)	
	100 mV/div	2.7 mV (42.3 dB)	3.1 mV (41.1 dB)	
	200 mV/div	6.6 mV (40.6 dB)	8.2 mV (38.7 dB)	
	500 mV/div	14 mV (42.0 dB)	17 mV (40.3 dB)	
	1 V/div	27 mV (42.3 dB)	32 mV (40.9 dB)	
	input sensitivity	R&S®RTP084	R&S®RTP134	
	2 mV/div	430 µV (24.3 dB)	670 μV (20.5 dB)	
	5 mV/div	440 μV (32.1 dB)	720 µV (27.8 dB)	
	10 mV/div	620 μV (35.1 dB)	900 μV (31.9 dB)	
	20 mV/div	880 μV (38.1 dB)	1.3 mV (34.7 dB)	
	50 mV/div	2.0 mV (38.9 dB)	2.7 mV (36.3 dB)	
	100 mV/div	3.6 mV (39.8 dB)	4.3 mV (38.3 dB)	
	200 mV/div	9.8 mV (37.2 dB)	12 mV (35.4 dB)	
	500 mV/div	21 mV (38.5 dB)	27 mV (36.3 dB)	
	1 V/div	36 mV (39.8 dB)	43 mV (38.3 dB)	
	input sensitivity	R&S®RTP164		
	2 mV/div	750 μV (19.5 dB)		
	5 mV/div	800 μV (26.9 dB)	800 µV (26.9 dB)	
	10 mV/div	1.0 mV (31.0 dB)	1.0 mV (31.0 dB)	
	20 mV/div	1.5 mV (33.5 dB)		
	50 mV/div	3.0 mV (35.4 dB)		
	100 mV/div	4.8 mV (37.3 dB)		
	200 mV/div	14 mV (34.1 dB)		
	500 mV/div	30 mV (35.4 dB)		
	1 V/div	48 mV (37.3 dB)		

Horizontal system

Timebase range		selectable between 20 ps/div and 10 000 s/div.
		time per div settable to any value within
		range
Channel deskew		±100 ns
Reference position		0 % to 100 % of measurement display
		area
Trigger offset range	max.	+(memory depth/current sampling rate)
	min.	-10 000 s
Modes		normal, roll
Channel-to-channel skew		< 10 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±10 ppb
	during calibration interval	±100 ppb
	long-term stability	\pm (50 + 50 × years since calibration) ppb
	(more than one year since calibration)	
Sample clock jitter	acquired time range	RMS value (meas.)
	1 μs	50 fs
	10 μs	63 fs
	100 µs	72 fs
	1 ms	76 fs
	10 ms	124 fs
Intrinsic jitter	RMS value	200 fs (meas.)
Time interval error (TIE)	RMS values	$\sqrt{\text{(Noise/SlewRate)}^2 + (Intrinsic Jitter)^2}$
Periodic jitter	RMS values	$\sqrt{2}\sqrt{(\text{Noise/SlewRate})^2 + (\text{Intrinsic Jitter})^2}$
Cycle-to-cycle jitter	RMS values	$\sqrt{3}\sqrt{\text{(Noise/SlewRate)}^2 + \text{(Intrinsic Jitter)}^2}$

Acquisition system

Realtime sampling rate		max. 20 Gsample/s on 4 channels,
Realtime waveform acquisition rate	max.	max. 40 Gsample/s on 2 channels > 750 000 waveforms/s
Memory depth ²	standard	50 Msample on 4 channels
Memory depth	Standard	100 Msample on 2 channels
		200 Msample on 1 channel
	R&S®RTP-B101 option	100 Msample on 4 channels
	R&S KTF-BTOT OPHOLI	200 Msample on 2 channels
	December Dates	400 Msample on 1 channel
	R&S®RTP-B102 option	200 Msample on 4 channels
		400 Msample on 2 channels
	DO CODTO DAOS	800 Msample on 1 channel
	R&S®RTP-B105 option	500 Msample on 4 channels
		1 Gsample on 2 channels
		2 Gsample on 1 channel
	R&S®RTP-B110 option	1 Gsample on 4 channels
		2 Gsample on 2 channels
Realtime digital filters	selectable for the data acquisition and/or	
	lowpass for acquisition system	cutoff frequency selectable from 100 kHz
		to 500 MHz
	lowpass for acquisition and trigger	cutoff frequency selectable from 1 GHz to
	system	the analog bandwidth with fine granularity
Decimation modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval
	high resolution	average value of samples in decimation interval
	root mean square	root of squared average of samples in decimation interval
Waveform arithmetic	off	no arithmetic
	envelope	envelope of acquired waveforms
	average	average of acquired waveforms,
	an enaige	max. average depth depends on
		decimation mode ³
	sample	max. 16 777 215
	high resolution	max. 65 535
	root mean square	max. 255
	reset condition	no reset (standard), reset by time, reset
	reset condition	by number of processed waveforms
Waveform streams per channel		up to 3 with independent selection of
vvavolomi streams per charmer		decimation mode and waveform arithmetic
Sampling modes	roaltimo modo	
Sampling modes	realtime mode	max. sampling rate set by digitizer
	interpolated time	interpolation; max. equivalent sampling
Internalation mades		rate is 5 Tsample/s
Interpolation modes Ultra-segmented mode	= -	linear, sin(x)/x, sample&hold uisition memory without interruption due to
	visualization	> 2.000.000 wayofarma/a
	max. realtime waveform acquisition rate	> 3 000 000 waveforms/s
	min. blind time between consecutive acquisitions	< 350 ns

² The maximum available memory depth depends on the bit depth of the acquired data and, therefore, on the settings of the acquisition system, such as decimation mode, waveform arithmetic, number of waveform streams and high definition mode.

 $^{^{\}rm 3}$ $\,$ Waveform averaging is not compatible with peak detect decimation.

Differential signals

General description	Calculation of differential and common mode signals from p part and n part connected to separate input channels. Because of the R&S®RTP digital trigger concept, these signals can be used as a trigger input.	
Input channels		channel 1, channel 2, channel 3, channel 4
Differential signal		difference between any two input channels
Common mode signal		sum of any two input channels
Maximum number of outputs ⁴	differential signals	2
	common mode signals	2

High definition mode

General description	using digital filtering, leading to a	The high definition mode increases the numeric resolution of the waveform signal by using digital filtering, leading to a reduced noise. Because of the R&S®RTP digital trigger concept, the signals with increased numeric resolution are used as input for triggering.	
Numeric resolution	bandwidth	resolution	
	10 kHz to 200 MHz	16 bit	
	300 MHz	12 bit	
	500 MHz	12 bit	
	1 GHz	11 bit	
	2 GHz	10 bit	
Realtime sampling rate		max. 10 Gsample/s on each channel	

Trigger system

Sources		channel 1, channel 2, channel 3,
		channel 4, inverted channels, external
		trigger, line trigger, differential, common
		mode
Sensitivity		10 ⁻⁴ div, from DC to instrument bandwidth
		for all vertical scales
Trigger jitter	full-scale sine wave of frequency set to	< 1 ps (RMS) (meas.)
	-3 dB bandwidth	
Coupling mode	standard	same as selected channel
	lowpass filter	cutoff frequency selectable from 1 GHz to
		analog bandwidth
Sweep mode		auto, normal, single, n single
Event rate	max.	one event for every 200 ps time interval
Trigger level	range	±5 div from center of screen
Trigger hysteresis	modes	auto (standard) or manual
	sensitivity	10 ⁻⁴ div, from DC to instrument bandwidth
		for all vertical scales
Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

⁴ Together with R&S®RTP-K122 realtime deembedding only one output can be calculated, differential or common mode.

Main trigger modes				
Edge	triggers on specified slope (pos	triggers on specified slope (positive, negative or either) and level		
Glitch	triggers on glitches of positive, specified width	triggers on glitches of positive, negative or either polarity that are shorter or longer than		
	glitch width	25 ps to 10 000 s		
Width	triggers on positive or negative inside or outside the interval	pulse of specified width; width can be shorter, longer,		
	pulse width	25 ps to 10 000 s		
Runt	fails to cross a second threshol	egative or either polarity that crosses one threshold but d before crossing the first one again; runt pulse width		
	can be arbitrary, shorter, longe			
	runt pulse width	25 ps to 10 000 s		
Window		exits a specified voltage range; triggers also when signal		
		age range for a specified period of time		
Timeout	triggers when signal stays high	triggers when signal stays high, low or unchanged for a specified period of time		
	timeout	25 ps to 10 000 s		
Interval	triggers when time between two	triggers when time between two consecutive edges of same slope (positive or		
	negative) is shorter, longer, ins	negative) is shorter, longer, inside or outside a specified range		
	interval time	25 ps to 10 000 s		
Slew rate	triggers when the time required	by a signal edge to toggle between user-defined upper		
	and lower voltage levels is sho	rter, longer, inside or outside the interval; edge slope		
	may be positive, negative or eit	ther		
	toggle time	25 ps to 10 000 s		
Data2clock	triggers on setup time and hold	time violations between clock and data present on any		
	two input channels; monitored	two input channels; monitored time interval may be specified by the user in the range		
	from -100 ns to 100 ns around	from -100 ns to 100 ns around a clock edge and must be at least 100 ps wide		
Pattern				
	for a period of time shorter, lon	for a period of time shorter, longer, inside or outside a specified range		
State		ation (and, nand, or, nor) of the input channels stays true		
		r either) in one selected channel		

Advanced trigger modes			
Trigger qualification	trigger events may be qualified by a logical combination of unused channels		
	qualifiable events	edge, glitch, width, runt, window, timeout, interval	
Sequence trigger (A/B/R trigger)		triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events; an optional R event resets the trigger sequence to A	
	A event	any trigger mode	
	B event	edge, glitch, width, runt, window, timeout, interval, slew rate	
	R event	edge, glitch, width, runt, window, timeout, interval, slew rate	
Zone trigger		with R&S®RTP-K19 option	
External trigger input	input impedance	50 Ω (nom.)	
	max. input voltage	5 V (RMS)	
	trigger level range	±5 V	
	sensitivity, for input frequency ≤ 500 MHz	300 mV (peak-to-peak)	
	input coupling	50 Ω, GND,	
		HF reject (attenuates > 50 kHz),	
		LF reject (attenuates < 50 kHz)	
	trigger modes	edge (rise or fall)	
Trigger out	functionality	a pulse is generated for every acquisition trigger event	
	output voltage	0 V to 5 V at high impedance	
		0 V to 2.5 V at 50 Ω	
	pulse width	selectable between 4 ns and 60 ms	
	pulse polarity	low active or high active	
	output delay	depends on trigger settings	
	jitter	±600 ps (meas.)	

RF characteristics ⁵

Sensitivity/noise density	at 1.001 GHz	-157 dBm (1 Hz) (meas.)
,	(measurement of the power spectral	
	density at 1.001 GHz at input sensitivity	
	2 mV/div, corresponding to -30 dBm input	
	range of the oscilloscope, using the FFT	
	with center frequency 1.001 GHz, span	
	500 kHz, RBW 1 kHz)	
Noise figure	at 1.001 GHz	17 dB (meas.)
G	(calculated based on the noise density	,
	above)	
Dynamic range	measured for an input carrier with	111 dB (meas.)
	frequency 1 GHz and level -1 dBm at	
	input sensitivity 70 mV/div, corresponding	
	to 0 dBm input range of the oscilloscope,	
	using the FFT with center frequency	
	1 GHz, span 100 MHz, RBW 400 Hz at	
	+20 MHz from the center frequency	
Absolute amplitude accuracy	input frequency	
	≤ 12 GHz	±0.25 dB (meas.)
	> 12 GHz to ≤ 15 GHz	±0.5 dB (meas.)
Phase noise	at 1 GHz	
	10 kHz offset	-118 dBc (1 Hz) (meas.)
	100 kHz offset	-126 dBc (1 Hz) (meas.)
EVM	802.11, 20 MHz bandwidth, 64 QAM	
	802.11n, 2.4 GHz carrier	-46 dB (meas.)
	802.11ac, 5.7 GHz carrier	-44 dB (meas.)
Spurious-free dynamic range	measured for an input carrier with	66 dB (meas.)
(excl. harmonics)	frequency 950 MHz and level -1 dBm at	
	input sensitivity 70 mV/div, corresponding	
	to 0 dBm input range of the oscilloscope,	
	using the FFT with center frequency	
	3 GHz, span 5 GHz, RBW 100 kHz	
Second harmonic distortion	measured for an input carrier with	-52 dBc (meas.)
	frequency 950 MHz and level -1 dBm at	
	input sensitivity 70 mV/div, corresponding	
	to 0 dBm input range of the oscilloscope,	
	using the FFT with center frequency	
	3 GHz, span 5 GHz, RBW 100 kHz	
Third harmonic distortion	measured for an input carrier with	-46 dBc (meas.)
	frequency 950 MHz and level –1 dBm at	
	input sensitivity 70 mV/div, corresponding	
	to 0 dBm input range of the oscilloscope,	
	using the FFT with center frequency	
Third and a fatament 1 / (TO)	3 GHz, span 5 GHz, RBW 100 kHz	05 dD ()
Third-order intercept point (TOI)	measured for two input tones with	25 dBm (meas.)
	frequencies 2.436 GHz and 2.438 GHz	
	and level 0 dBm at input sensitivity	
	160 mV/div, corresponding to 8 dBm input	
	range of the oscilloscope,	
	using the FFT with center frequency	
In and MOMP	2.437 GHz, span 10 MHz, RBW 30 kHz	
Input VSWR	input frequency	4.05 ()
	≤ 4 GHz	1.25 (meas.)
	> 4 GHz to ≤ 16 GHz	1.4 (meas.)

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⁵ The RF characteristics are measured for an R&S®RTP164 oscilloscope with 16 GHz bandwidth at zero offset.

Waveform measurements

General features	measurement panels	up to 8 measurement panels; each panel may contain any number of automatic
		measurements of the same category
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic
	statistics	measurements displays maximum, minimum, mean, standard deviation, RMS and measurement count for each automatic measurement
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source
	long-term analysis	history of selected measurements as trace against count index
	histogram	available for the main measurement of each measurement panel; automatic or manual selection of bin number and scale;
		counters for measurements under, within and over the histogram range
	limit check	measurements tested against user- defined margins and limits; pass or fail conditions may launch automatic response: acquisition stop, beep, print
Measurement category	amplitude and time	and save waveform amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, overshoot, area, rise time, fall time, positive width, negative width, period, frequency, duty cycle, delay, phase, burst width, pulse count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup/hold time, setup/hold ratio, pulse train, slew rate rising, slew rate falling, DC voltmeter (requires Rohde & Schwarz active probe with R&S®ProbeMeter functionality)
	eye diagram	extinction ratio, eye height, eye width, eye top, eye base, Q factor, S/N ratio, duty cycle distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to-peak, 6-sigma, RMS)
	spectrum	channel power, bandwidth, occupied bandwidth, harmonic search, total harmonic distortion THD in dB and % using power values, total harmonic distortion variants THD _a , THD _u and THD _r using voltage, overall voltage and overall voltage root means square, peak list (THD _a , THD _u , THD _r and peak list require R&S®RTP-K37 option)
	jitter	cycle-to-cycle jitter, N-cycle jitter, cycle-to- cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; requires R&S®RTP-K12 option

Cursors	setup	up to 4 cursor sets on screen, each set consisting of two horizontal and two vertical cursors
	target	acquired waveforms (input channels), math waveforms, reference waveforms, track waveforms, XY diagrams
	operating mode	vertical measurements, horizontal measurements or both; vertical cursors either set manually or locked to waveform
Histogram	source	acquired waveform (input channels), math waveform, reference waveform
	mode	vertical (for timing statistics), horizontal (for amplitude statistics)
	automatic measurements	waveform count, waveform samples, histogram samples, histogram peak, peak value, maximum, minimum, median, range, mean, sigma, mean ± 1, 2 and 3 sigma, marker ± probability

Mask testing

Test definition	number of masks	up to 8 simultaneously
	source	acquired waveforms (input channels), math waveforms
	fail condition	sample hit or waveform hit
	fail tolerance	minimum number of fail events for test fail in range from 0 to 4 000 000 000
	test rate	up to 600 000 waveforms/s
	action on error	acquisition stop, beep, print and save waveform
	save/load to file	test and mask settings (.xml format)
Mask definition with segments	number of independent segments	up to 8
-	segment definition	array of points and connecting rule (upper, lower, inner) define segment region
	segment input	point and click on touchscreen, editable list
Mask definition with tolerance tube	input signal	acquired waveform
	definition of tolerance tube	horizontal width, vertical width, vertical stretch, vertical position
Mask definition with eye mask assistant	primary mask shape	
(requires R&S®RTP-K12 option)	type	diamond, square, hexagon, octagon
· ,	dimensions	main and secondary height, main and secondary width, depending on selected shape
	position	vertical offset, horizontal offset
	secondary mask shapes	
	locations	any combination of left, right, top, bottom
	position	horizontal and vertical offset with respect to center of primary mask shape
Result statistics	category	completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail)
Visualization options	waveform style	vectors, dots
	violation highlighting	hits (on/off), highlight persistence (50 ms to 50 s or infinite), waveform color (default: red)
	mask colors	configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red)

Waveform math

General features	number of math waveforms	up to 4		
	number of reference waveforms	up to 4		
	waveform arithmetic	user-selectable average or envelope of		
		consecutive waveforms		
Algebraic expressions	user may define complex mathematical e	xpressions involving waveforms and		
	measurement results	measurement results		
	math functions	add, subtract, multiply, divide, absolute		
		value, square, square root, integrate,		
		differentiate, exp, log ₁₀ , log _e , log ₂ , rescale,		
		sin, cos, tan, arcsin, arccos, arctan, sinh,		
		cosh, tanh, autocorrelation,		
		crosscorrelation		
	logical operators	not, and, nand, or, nor, xor, nxor		
	relational operators	Boolean result of =, \neq , >, <, \leq , \geq		
	frequency domain	spectral magnitude and phase, real and		
		imaginary spectra, group delay		
	digital filter	lowpass, highpass		
	special functions	CDR transform; requires R&S®RTP-K12		
		option		
Optimized math	operators	add, subtract, multiply, invert, absolute		
		value, differentiate, log ₁₀ , log _e , log ₂ ,		
		rescale, FIR, FFT magnitude		
Spectrum analysis	FFT magnitude spectrum			
	setup parameters	center frequency, frequency span, frame		
		overlap, frame window (rectangular,		
		Hamming, Hann, Blackman, Gaussian,		
		Flattop, Kaiser Bessel), user-selectable		
		spectrum averaging, RMS, envelope,		
		max. hold and min. hold (max. hold and		
		min. hold require R&S®RTP-K37 option)		
	max. realtime waveform acquisition	> 1 000 waveforms/s		
	rate			

Search and mark function

General description	scans acquired waveforms for oc highlights each occurrence	scans acquired waveforms for occurrence of a user-defined set of events and highlights each occurrence	
Basic setup	source	all physical input channels, math waveforms, reference waveforms	
	search panels	up to 8, where each panel may manage multiple event searches	
	search mode	manually triggered or continuous	
	search conditions	search conditions	
	supported events	edge, glitch, width, runt, window, timeout,	
		interval, slew rate, data2clock, state	
	event configuration	identical to corresponding trigger event	
	event selection	single or multiple events on same source	
Search scope	mode	current waveform, gated time interval	
Result visualization	table		
	sort mode	horizontal position or vertical value	
	max. result count	specifies max. table size	
	zoom window	centered on highlighted event	

Display characteristics

Diagram types	Yt, XY, spectrum, long-term measurement, spectrogram (spectrogram requires R&S®RTP-K37 option)	
Horizontal divisions	10	
Vertical divisions	10	
Display interface configuration	display area can be split up into separate diagram areas by dragging and dropping signal icons;	
	each diagram area can hold any number of signals;	
	diagram areas may be stacked on top of each other and later accessed via the dynamic tab menu	
Signal bar	accommodates timebase settings, trigger settings and signal icons;	
G	signal bar may be docked to left or right side of display area or hidden	
Signal icon	each active waveform is represented by a separate signal icon on the signal bar; the	
-	signal icon displays the individual vertical and acquisition settings; a waveform can be	
	minimized to its signal icon so that it appears as a realtime preview in miniature form;	
	dialog boxes and measurement results may also be minimized to a signal icon	
Axis label	X-axis ticks and Y-axis ticks labeled with tick value and physical unit	
Diagram label	diagrams may be individually labeled with a descriptive user-defined name	
Diagram layout	grid, crosshair, axis labels and diagram label may be switched on and off separately	
Persistence	50 ms to 50 s, or infinite	
Zoom	user-defined zoom window provides vertical and horizontal zoom;	
	each diagram area supports multiple zoom windows;	
	touchscreen interface simplifies resize and drag operations on zoom window	
Signal colors	predefined or user-defined color tables for persistence display	

Input and output

Front		
Channel inputs		BNC-compatible,
		for details see Vertical system
	probe interface	auto-detection of passive probes,
		Rohde & Schwarz active probe interface
External trigger input		BNC,
		for details see Trigger system
	probe interface	auto-detection of passive probes,
		Rohde & Schwarz active probe interface
Probe compensation output	signal shape	rectangle, V _{low} = 0 V, V _{high} = 1 V
		amplitude 1 V (V _{pp}) ± 5 %
	frequency	1 kHz ± 1 %
	impedance	50 Ω (nom.)
Ground jack		4 mm, connected to ground
USB interface		2 ports, type A plug, version 3.1 gen 1
Option slots		2

Version 12.00, April 2021

Rear		
Trigger out		BNC,
		for details see Trigger system
USB interface		2 ports, type A plug version 3.1 gen 1
		2 ports, type A plug version 2.0
		1 port, type B plug, version 3.1 gen 1
LAN interface		RJ-45 connector,
		supports 10/100/1000BASE-T
External monitor interface		DVI-D and display port,
		output of scope display or extended
		desktop display
GPIB interface	function	interface in line with IEC 625-2
		(IEEE 488.2)
	command set	SCPI 1999.0
	connector	IEEE-488 24-pin Amphenol female
	interface functions	SH1, AH1, T6, L4, SR1, RL1, PP1, DC1,
		DT1, C0
External reference input	connector	BNC female
	impedance	50 Ω (nom.)
	input frequency range	1 MHz to 20 MHz, in 1 MHz steps
	sensitivity	\geq 0 dBm into 50 Ω
Reference output 10 MHz	connector	BNC female
	impedance	50 Ω (nom.)
	level	> 7 dBm
Auxiliary output		SMA connector, for future use
Digital data interface 40G		QSFP+ connector, for future use
Option slots		2
Security slot		for standard Kensington style lock

General data

Display	type	12.1" LC TFT color display with capacitive
		touchscreen
	resolution	1280 × 800 pixel (WXGA)
Operating system		Windows 10 64-bit
Temperature		
Temperature loading	operating temperature range	+5 °C to +45 °C
Tomporature reading	storage temperature range	-40 °C to +70 °C
Temperature loading	otorage tomporature range	in line with MIL-PRF-28800F section
. oporataro roaag		4.5.5.1.1.1 class 3 for operation
Climatic loading		+25° C/+40 °C at 85 % rel. humidity
3		cyclic, in line with IEC 60068-2-30
		+30 °C/+40 °C/+45 °C at 95/75/45 %,
		in line with MIL-PRF-28800F section
		4.5.5.1.1.2 class 3 for operation
Altitoral		
Altitude Operating		up to 3000 m above sea level
Nonoperating		up to 15000 m above sea level
rionoperating		עף נט ושטטט ווו משטעפ שפמ ופעפו
Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz,
		0.5 g from 55 Hz to 150 Hz,
		in line with EN 60068-2-6
	random	10 Hz to 300 Hz,
		acceleration 1.2 g (RMS),
		in line with EN 60068-2-64
Shock		40 g shock spectrum,
		in line with MIL-STD-810E, method
		no. 516.4, procedure I
EMC		
RF emission		in line with CISPR 11/EN 55011 group 1
		class A (for a shielded test setup);
		the instrument complies with the emission
		requirements stipulated by EN 55011,
		EN 61326-1 and EN 61326-2-1 class A,
		making the instrument suitable for use in
		industrial environments
Immunity		in line with IEC/EN 61326-1 table 2,
		immunity test requirements for industrial
		environment ⁶
Certifications		VDE-GS, _C CSA _{US} , KC
Calibration interval		1 year
Power supply		
AC supply		100 V to 240 V at 50 Hz to 60 Hz,
cappij		100 V to 130 V at 400 Hz,
		max. 13 A to 4.7 A,
		in line with MIL-PRF 28800F section 3.5
Power consumption		max. 1000 W
Safety		in line with IEC 61010-1, EN 61010-1,
•		CAN/CSA-C22.2 No. 61010-1-12,
		UL 61010-1

⁶ Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

Version 12.00, April 2021

Mechanical data		
Dimensions (W × H × D)	with R&S®RTP-B20 handles	463 mm × 285 mm × 349 mm
		(18.23 in × 11.22 in × 13.74 in)
	with shock protection	441 mm × 285 mm × 316 mm
		(17.36 in × 11.22 in × 12.44 in)
Weight	without options, nominal	18.0 kg (39.68 lb)

Options

R&S®RTP-B1 mixed signal option

Mixed signal option, additional 16 logic channels

Vertical system

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with
		8 channels each, assignment of the logic
		probes to the channels (D0 to D7 or
		D8 to D15) is displayed on the probe
DC input resistance	at probe tips	100 kΩ ± 2 % (meas.)
Input capacitance		4 pF (meas.)
Maximum input frequency	signal with minimum input voltage swing	400 MHz (meas.)
	and hysteresis setting: normal	
Maximum input voltage		±40 V (V _p)
Minimum input voltage swing		500 mV (V _{pp}) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and
		D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V,
		TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold setting between ±4 V	±(100 mV + 3 % of threshold setting)
		(meas.)
Comparator hysteresis		normal, robust, maximum

Horizontal system

Channel deskew	range for each channel	±200 ns
Channel-to-channel skew		< 500 ps (meas.)

Acquisition system

Sampling rate	max.	5 Gsample/s on each channel
Realtime waveform acquisition rate	max.	> 200 000 waveforms/s
Memory depth	at max. sampling rates	200 Msample for every channel
	at lower sampling rates	100 Msample for every channel
Decimation		pulses lost due to decimation are
		displayed

Trigger system

Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

Trigger modes			
Edge	triggers on specified slope (pos	triggers on specified slope (positive, negative or either) in the source signal	
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
Width	triggers on positive or negative	e pulse of specified width in the source signal; width can	
	be shorter, longer, equal, insid	e or outside the interval	
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
	pulse width	200 ps to 10 s	
Timeout	triggers when the source signa	triggers when the source signal stays high, low or unchanged for a specified period of	
	time		
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
	timeout	200 ps to 10 s	
Data2clock	triggers on setup time and hold	d time violations between a clock signal and a data	
	signal; monitored time interval	signal; monitored time interval with a max. width of 200 ns and a position of	
	max. ±1 μs relative to the clock	max. ±1 μs relative to the clock edge	
	data signal	any subset of channels from D0 to D15 or	
		any user-defined bus signal	
	clock signal	any channel from D0 to D15	

Pattern	triggers when the source goes treequal, inside or outside a specific	rue or stays true for a period of time shorter, longer, led range
	sources	any logical combination of D0 to D15 or any user-defined bus signal
	pulse width	200 ps to 10 s
State	triggers on the slope (positive, n matches a user-defined logical s	egative or either) of the clock signal when data signal
	data signal	any logical combination of D0 to D15 or
	_	any user-defined bus signal
	clock signal	any channel from D0 to D15
Serial pattern		of up to 32 bit; pattern bits may be high (H), low (L) or may be positive, negative or either
	data signal	any channel from D0 to D15 or any logical combination of D15 to D15
	clock signal	any channel from D0 to D15
	max. data rate	1 Gbps
Serial bus trigger	optional	dedicated software options
	sources	any channel from D0 to D15

Waveform measurements

General features	measurement panels, gate, statistics,
	long-term analysis and limit check; see
	features of the base unit
Measurement sources	all channels from D0 to D15 or any logical
	combination of D0 to D15
Automatic measurements	positive pulse width, negative pulse width,
	period, frequency, burst width, delay,
	phase, positive duty cycle, negative duty
	cycle, positive pulse count, negative pulse
	count, rising edge count, falling edge
	count
Additional cursor function	display of decoded bus value at the cursor
	position

Waveform math

Function	any logical combination of D0 to D15
----------	--------------------------------------

Search and mark functions

The search function will be available in a future software release.

Display characteristics

Display of logical channels		selectable size and position on screen, diagram configuration by dragging and
		dropping signal icons
Bus decode	number of bus signals	4
	bus types	unclocked and clocked
	display types	decoded bus, logical signal, bus + logical signal, amplitude signal, amplitude + logical signal, tabulated list (decoded time interval selected with cursors)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, unsigned integer, signed integer, fractional, binary
	data format of amplitude signal	unsigned integer, signed integer, fractional, binary offset
Channel activity display		independent of the scope acquisition, the state (stays low, stays high or toggles) of the channels from D0 to D15 is displayed in the signal icon

R&S®RTP-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels, 8-bit pattern generator

Analog channels

General	
Output channel	2 channels
Vertical resolution	14 bit
Operating modes	function generator, arbitrary waveform generator, modulation, frequency sweep

Function generator	output of predefined waveforms	output of predefined waveforms	
Sample rate	·	500 Msample/s	
Waveforms		sine, square/pulse, ramp, DC, noise, sine cardinal (sinc), Gaussian pulse, Lorentz, exponential fall, exponential rise, cardiac	
Sine	frequency range	1 mHz to 100 MHz	
	amplitude flatness (relative to 1 kHz)		
	f ≤ 100 kHz	≤ ±0.1 dB	
	100 kHz < f ≤ 60 MHz	≤ ±0.3 dB	
	60 MHz < f ≤ 100 MHz	≤ ±0.5 dB	
	total harmonic distortion (1 V (Vpp) into 5	0 Ω)	
	f ≤ 100 kHz	≤ -70 dBc (= THD ≤ 0.032 %)	
	100 kHz < f ≤ 15 MHz	≤ –55 dBc	
	15 MHz < f ≤ 35 MHz	≤ -40 dBc	
	35 MHz < f ≤ 100 MHz	≤ -30 dBc	
	nonharmonic spurious (1 V (V_{pp}) into 50 Ω)	-65 dBc (meas.)	
	phase noise (meas.)		
	f ≤ 25 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,	
		≤ -115 dBc (1 Hz) at 10 kHz offset,	
		≤ -125 dBc (1 Hz) at 100 kHz offset	
	25 MHz < f ≤ 100 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,	
		≤ -110 dBc (1 Hz) at 10 kHz offset,	
		≤ -115 dBc (1 Hz) at 100 kHz offset	
Square/pulse	frequency range	1 mHz to 30 MHz	
	duty cycle (if pulse width limit is not exceeded)	0.01 % to 99.99 %, 0.01 % resolution	
	pulse width	≥ 16.5 ns, 0.1 ns resolution	
	rise/fall time		
	f ≤ 10 Hz	90 μs (meas.)	
	10 Hz < f ≤ 30 MHz	9 ns (meas.)	
	overshoot	≤ 2 %	
	jitter (cycle-to-cycle)	≤ 40 ps (RMS) (meas.)	
Ramp (triangle, sawtooth)	frequency range	1 mHz to 1 MHz	
,	linearity	≤ 0.1 % (meas.)	
	variable symmetry	0 % to 100 %, 0.1 % resolution	
DC	level range	•	
	into 50 Ω	± [3 V – (noise amplitude [V _{pp}] / 2)]	
	into open circuit	± [6 V – (noise amplitude [V _{pp}] / 2)]	
Noise	amplitude		
	DC	0 V to 6 V (V _{pp}) (into 50 Ω)	
		0 V to 12 V (V _{pp}) (into open circuit),	
		4 digits resolution	
	all other waveforms	0 % to 100 % of AC signal amplitude,	
		1 % resolution	
	bandwidth	≥ 100 MHz	
Sine cardinal (sinc)	frequency range	1 mHz to 2 MHz	
Gaussian pulse	frequency range	1 mHz to 10 MHz	
Lorentz	frequency range	1 mHz to 5 MHz	
Exponential rise/fall	frequency range	1 mHz to 1 MHz	
Cardiac	frequency range	1 mHz to 1 MHz	

Arbitrary waveform generator	output of user-defined waveforms	
Waveform length		1 sample to 40 Msample on each channel
Sample rate		1 sample/s to 250 Msample/s
Filter bandwidth		100 MHz

Modulation		
Sample rate		500 Msample/s
Modulation types		amplitude modulation (AM), frequency modulation (FM), frequency-shift key modulation (FSK), pulse width modulation (PWM)
Carrier waveform	AM, FM, FSK	sine
	PWM	square/pulse
AM	modulation signals	sine, square, ramp (triangle, sawtooth)
	modulation frequency	1 mHz to 1 MHz
	depth	0 % to 100 %, 0.1 % resolution
FM	modulation signals	sine, square, triangle, ramp, inverse ramp
	modulation frequency	1 mHz to 1 MHz
	frequency deviation	1 mHz to 10 MHz
FSK	modulation signal	50 % duty cycle square wave
	range of frequency 1, frequency 2	1 mHz to 100 MHz
	hop rate	1 mHz to 1 MHz
PWM	modulation signals	sine, square, ramp
	depth	0 % to 99.99 % of the duty cycle,
		0.01 % resolution

Frequency sweep	output of a sinusoidal waveform with the frequency changing linearly between the start frequency and the stop frequency within the sweep time	
	sample rate	500 Msample/s
	waveform	sine
	frequency range	1 mHz to 100 MHz
	direction	up (start frequency < stop frequency)
		down (start frequency > stop frequency)
	sweep time	1 ms to 500 s

Two-channel operation	operating modes	independent channels, coupled
		parameters, differential
	parameter coupling	none, frequency and/or amplitude
	relative phase	-180° to 180°, 0.1° resolution
	channel-to-channel skew	≤ 200 ps (meas.)
	channel-to-channel isolation	
	(each channel with same output amp	olitude)
	f ≤ 10 MHz	≥ 60 dB (meas.)
	10 MHz < f ≤ 100 MHz	≥ 40 dB (meas.)

Outputs		
Connectors		BNC female on the rear panel
Function		on, off, inverted
Output impedance		50 Ω (nom.)
Overload protection		a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages
		≥ +7 V or ≤ -7 V (meas.), automatic shutoff in case of overcurrent, max20 V to +20 V without damage (meas.), ESD protection
Amplitude range 7	sine, square/pulse, ramp, pulse,	exponential rise, exponential fall
, ,	into 50 Ω	10 mV to 6 V (V_{pp}) (frequency \leq 50 MHz), 10 mV to 4 V (V_{pp}) (frequency $>$ 50 MHz)
	into open circuit	20 mV to 12 V (V _{pp}) (frequency ≤ 50 MHz), 20 mV to 8 V (V _{pp}) (frequency > 50 MHz)
	sine cardinal (sinc)	, , , , , , , , , , , , , , , , , , , ,
	into 50 Ω	10 mV to 3 V (V _{pp})
	into open circuit	20 mV to 6 V (V _{DD})
	Gauss, Lorentz	()
	into 50 Ω	10 mV to 2.5 V (V _{pp})
	into open circuit	20 mV to 5 V (V _{pp})
	arbitrary waveforms	23 πν το σ ν (ν μρ)
	into 50 Ω	10 mV to 6 V (V _{pp})
	11110 00 12	(sample rate ≤ 125 Msample/s),
		10 mV to 4 V (V _{pp})
		(sample rate > 125 Msample/s)
	into open circuit	20 mV to 12 V (V _{pp})
		(sample rate ≤ 125 Msample/s),
		20 mV to 8 V (V _{pp})
		(sample rate > 125 Msample/s)
	resolution	1 mV
	accuracy	± [1% of control + 1 mV (V _{pp})] at 1 kHz
DC offset range	sine, square/pulse, ramp, pulse, exponential rise, exponential fall	
	into 50 Ω	± [3 V – (amplitude [V (V _{pp})] / 2)]
	into open circuit	± [6 V – (amplitude [V (V _{pp})] / 2)]
	sine cardinal (sinc), Gauss, Lorentz	
	into 50 Ω	±0.5 V
	into open circuit	±1 V
	resolution	1 mV
	accuracy	± (2 % of control + 2 mV)
Frequency accuracy		$ \Delta f \le [\text{(timebase accuracy)} \times (\text{nominal})$
- 1 ,,		frequency) + 1 µHz]
		(timebase accuracy: see Horizontal
	1	(

-

 $^{^{\}rm 7}$ $\,$ Amplitude is the sum of the AC amplitude and the noise amplitude.

8-bit pattern generator

Function	output of user-defined patterns
Output channels	8 channels, coupled w.r.t. pattern length
	and data output rate
Pattern length	1 bit to 40 Mbit on each channel
Bit rate	1 bit/s to 40 Mbit/s

Outputs		
Connector		16-pin double row connector, 2.54 mm pitch, located on an adapter board, which is connected via a removable ribbon cable to the R&S®RTO-B6
Output impedance		330 Ω (nom.)
Overload protection	reverse input voltage without damage	-0.5 V to +6.5 V (meas.), ESD protection
Amplitude	low level output voltage (I = 100 μA)	
	output voltage	0 V + 0.15 V/- 0.02 V
	accuracy	≤ 0.15 V (meas.)
	high level output voltage	
	setting range	1.2 V to 5.0 V
	resolution	0.1 V
	accuracy	≤ 0.05 V
Rise/fall time		8 ns (meas.)
Overshoot		≤ 5 % (meas.)

R&S®RTP-B7 16 GHz differential pulse source

16 GHz differential pulse source with reference output

Output 8

Output pulse		two complementary negative going square wave pulse train signals, single-ended or differential operation, fast transition on rising and falling edge, adjustable amplitude and timing parameters, free-running or phase-locked to base unit
Outputs	single-ended operation	single-ended output (OutP)
		single-ended reference output (RefP)
	differential operation	differential output (OutP, OutN)
		differential reference output (RefP, RefN)
Output connectors		SMA female connectors
Reverse DC voltage		0 V
Output impedance	single-ended outputs	50 Ω (nom.)
	both differential pairs	100 Ω (nom.)
Return loss	≤ 10 GHz	> 15 dB (meas.)
	≤ 20 GHz	> 12 dB (meas.)

DC characteristics 8

Output high level		0 V ± 10 mV
Output low level		–200 mV to –50 mV
setting range		adjustable in 10 mV steps
Output low level error	OutP	±2 % of setting ±15 mV
Output low level imbalance	between OutP and RefP, OutN, RefN	±1 dB (meas.)

⁸ All four outputs terminated with 50 Ω; all parameters are measured at all four single-ended outputs, unless noted.

Time domain characteristics 8

Transition time	10 % to 90 %, rising and falling edge, cald	culated from 0.36/bandwidth
	output low level: -120 mV to -50 mV	20 ps
	output low level: -200 mV to -130 mV	22 ps
Step response aberrations	for the first 100 ps after step transition	±10 % (meas.)
	for the first 1 ns after step transition	±4 % (meas.)
	until 100 ps before following step transition	±2 % (meas.)
Repetition rate	low frequency mode	5 Hz, 10 Hz, 20 Hz, 50 Hz, 100 Hz, 200 Hz, 500 Hz to 1 MHz
	high frequency mode, phase-locked to base unit	5 MHz, 10 MHz, 25 MHz, 50 MHz, 100 MHz, 250 MHz
	high frequency mode, free-running	5 MHz, 10 MHz, 25 MHz, 50 MHz
Positive duty cycle	measured at 50 % of transition	
	low frequency mode	10 % to 90 %, adjustable in 10 % steps
	high frequency mode	50 %
Duty cycle error	measured at 50 % of transition, at OutP and RefP outputs	
	low frequency mode	±2 % (meas.)
	high frequency mode	±0.1 % (meas.)
Skew	measured at 50 % of transition, between OutP and OutN output	< 0.5 ps (meas.)
Clock accuracy	free-running	±100 ppm (meas.)
•	phase-locked to base unit	see Timebase accuracy of base unit

Frequency domain characteristics 8

Analog bandwidth (-3 dB)	output low level: -120 mV to -50 mV	> 18 GHz (meas.)
	output low level: -200 mV to -130 mV	> 16.5 GHz (meas.)
Spectral magnitude error to ideal step	≤ 5 GHz	+0.5 dB to -1 dB (meas.)
spectrum	≤ 12 GHz	+0.5 dB to -2 dB (meas.)
	≤ analog bandwidth	+0.0 dB to -3 dB (meas.)

R&S®RTP-B21 adapter rear option slot

General description	The R&S®RTP-B21 adapter is necessary to use the R&S®RTP-B1 or the
	R&S®RTP-B1E option at the rear side of the instrument. For mounting instructions,
	please see R&S®RTP user manual.

R&S®RTP-K1 I²C/SPI serial triggering and decoding

I ² C triggering and decoding		
Protocol configuration	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration for I ² C triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	bit rate	up to 6.5 Mbps
	trigger event setup	start, stop, restart, missing ACK, address, data, address + data
	address setup	7 bit or 10 bit address (value in hex, decimal, octal or binary); ACK, NACK or either; read, write or either; R/W bit included in address value or apart; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition $=$, \neq , \geq , \leq , in range, out of range; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, start/restart, address, R/W bit, data ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII; symbolic names for user-defined subset of addresses
	decode layer	off, edges, bits
Search	search event setup	combination of start, stop, restart, missing ACK, address, data, address + data
	event settings	same as trigger event settings

SPI triggering and decoding		
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	auto-detected
	bit order	LSB first, MSB first
	word size	4 bit to 32 bit
	frame condition	SS, timeout
	polarity (MOSI, MISO, SS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
	auto threshold setup	assisted threshold configuration for SPI triggering and decoding
Trigger	source (MOSI, MISO, SS, CLK)	any input channel or logical channel
	bit rate	up to 50 Mbps
	trigger event setup	start of frame, MOSI, MISO, MOSI + MISO
	data setup	data pattern up to 256 bit (hex or binary);
		condition =, ≠; offset within frame in range from 0 bit to 32767 bit
Decode	source (MOSI, MISO, SS, CLK)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII
	decode layer	edges, bits, words
Search	search event setup	start of frame, MOSI, MISO, MOSI + MISO
	event settings	same as trigger event settings

R&S®RTP-K2 UART/RS-232/RS-422/RS-485 serial triggering and decoding

Protocol configuration	bit rate	300 bps to 20 Mbps	
	signal polarity	idle low, idle high	
	number of bits	5 bit to 9 bit	
	bit order	LSB first, MSB first	
	parity	odd, even, mark, space, none	
	stop bit	1, 1.5 or 2 bit periods	
	end of packet	word, timeout, none	
	auto threshold setup	assisted threshold configuration for	
		UART triggering and decoding	
Trigger	source (TX and RX)	any input channel or logical channel	
	trigger event setup	start bit, packet start, data, parity error,	
		break condition	
	data setup	data pattern up to 256 bit (hex, decimal,	
		octal, binary or ASCII); condition =, ≠;	
		offset within packet in range 0 bit to	
		32767 bit	
Decode	source (TX and RX)	any input channel, math waveform,	
		reference waveform, logical channel	
	display type	decoded bus, logical signal, bus + logical	
		signal, tabulated list	
	color coding	packet, data payload, start error, parity	
		error, stop error	
	data format	hex, decimal, octal, binary, ASCII	

R&S®RTP-K3 CAN/LIN serial triggering and decoding

CAN triggering and decoding Protocol configuration	signal type	CAN_H, CAN_L
1 Totodor comigaration	bit rate	100 bps to 1 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID
	device not	load DBC file content
	auto threshold setup	assisted threshold configuration for CAN
	auto umosmola ostap	triggering and decoding
Trigger	source	any input channel or logical channel
55	trigger event setup	start of frame, frame type, identifier,
	1	identifier + data, symbolic, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
		identifier type (standard or extended);
		condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal,
		octal or binary); big-endian or little-endian
		condition =, \neq , \geq , \leq , in range, out of range
	symbolic setup	message name, signal name;
		numeric signal condition =, ≠, ≥, ≤, in
		range, out of range;
		enumerated signal condition =, ≠, ≥, ≤
Decode	source	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, DLC, data
		payload, CRC, end of frame, error frame,
		overload frame, CRC error, bit stuffing
		error
	data format	hex, decimal, octal, binary, ASCII,
		symbolic
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type,
		identifier, identifier + data, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error) or only
		symbolic
	event settings	same as trigger event settings

LIN triggering and decoding		
Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic is supported
	bit rate	standard bit rate (1.2/2.4/4.8/9.6/10.417/ 19.2 kbps) or user-defined bit rate in range from 1 kbps to 20 kbps
	device list	associate frame identifier with symbolic ID, data length and protocol version
	auto threshold setup	assisted threshold configuration for LIN triggering and decoding
Trigger	source	any input channel
	trigger event setup	start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error)
	identifier setup	range from 0d to 63d; select condition =, ≠, ≥, ≤, in range, out of range for trigger "identifier"; select single identifier and condition = for trigger "identifier + data"
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition =, \neq , \geq , \leq , in range, out of range
Decode	source (TX and RX)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, frame identifier, data payload, checksum, error condition
	data format	hex, decimal, octal, binary, ASCII
Search	search event setup	combination of start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error)
	event settings	same as trigger event settings

R&S®RTP-K6 MIL-STD-1553 serial triggering and decoding

Protocol configuration	signal type	single-ended
3. 3. 5. 5. 5. 5. 5. 5. 5. 5. 5. 5. 5. 5. 5.	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (2 µs to 262 µs) or off;
	9	max. response (2 µs to 262 µs) or off
Trigger	trigger event setup	sync, word, data word, command/status word, command word, status word, error condition
	sync and word setup	all words, command/status word, data word
	data word setup	RTA (condition =, \neq , \geq , \leq , in range, out of range); data pattern (condition =, \neq , \geq , \leq , in range, out of range); payload data index (=, $<$, $>$, \geq , \leq , range); max. length of data pattern is 4 byte
	command/status word setup	RTA (condition =, \neq , \geq , \leq , in range, out of range); 11 bit pattern (condition =, \neq , \geq , in range, out of range)
	command word setup	RTA (condition =, \neq , \geq , \leq , in range, out of range); subaddress/mode (condition =, \neq , \geq , \leq , in range, out of range); data word count/mode count (condition =, \neq , \geq , \leq , in range, out of range); direction (T/R)
	status word	RTA (condition =, ≠, ≥, ≤, in range, out of range); status flags (message error, instrumentation, service request, broadcast command, busy, subsystem flag, dynamic bus control, terminal flag)
	error condition	any combination of sync error, Manchester error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), sync, RTA, status bit field, parity, data field, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	sync, word, data word, command/status
		word, command word, status word, error condition

R&S®RTP-K7 ARINC 429 serial triggering and decoding

Protocol configuration	signal type	single-ended
	bit rate	high (100 kbit/s)
		low (12 kbit/s to 14.5 kbit/s)
	polarity	A leg, B leg
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (0 bit to 100 bit) or off; max. gap (0 bit to 1000 bit) or off
Trigger	trigger event setup	word start, word stop, label + data, error condition
	label + data setup	label (condition =, \neq , \geq , \leq , in range, out of range); data (condition =, \neq , \geq , \leq , in range, out of range); SDI/SSM
	error condition	any combination of coding error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), label, SDI, data, SSM, parity, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	word start, word stop, label + data, error condition
	event settings	same as trigger event settings

$R\&S^{@}RTP\text{-}K8$ Ethernet (10BASE-T/100BASE-Tx) serial triggering and decoding

Protocol configuration	signal type	one channel, differential
	bit rate	selectable/adjustable
	auto threshold setup	assisted threshold configuration
	full autoset	adjust horizontal and vertical resolution
		and perform auto threshold
	source (SDATA)	analog and math channels
	variants	10BASE-T, 100BASE-TX
Trigger	frame start	trigger at start of any MAC frame
	pattern	fast trigger for 10BASE-T MAC frames, 32 bytes, index 0 to 65535
	frame	advanced trigger configuration for MAC
		frames only
		48 bit destination address, 48 bit source
		address, 16 bit length/type, 32 bit frame
		check; conditions =, \neq , <, \leq , >, \geq , in range,
		out of range
	error	preamble error, length error, CRC error
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, details, decode layers
	color coding	preamble, frame, destination address,
		source address, data
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, binary
Search	search event setup	frame, error
	event settings	same as trigger event settings

R&S®RTP-K9 CAN-FD serial triggering and decoding

Protocol configuration	signal type	CAN_H, CAN_L	
	standard	ISO, non-ISO (Bosch)	
	bit rate		
	arbitration rate	10 kbps to 1 Mbps	
	data rate	10 kbps to 15 Mbps	
	sampling point	5 % to 95 % within bit period; independent settings for arbitration phase and data phase	
	device list	associate frame identifier with symbolic ID, load DBC file content	
	auto threshold setup	assisted threshold configuration	
Trigger	source	any input channel or logical channel	
	trigger event setup	start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)	
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range	
	FD bits	FDF, BRS and ESI (0, 1, X)	
	data setup	data pattern up to 8 byte in the complete data range (hex, decimal, octal or binary); condition =, \neq , \geq , \leq , in range, out of range	
	symbolic setup	message name, signal name; numeric signal condition =, \neq , \geq , \leq , in range, out of range; enumerated signal condition =, \neq , \geq , \leq	
Decode	source	any input channel, math waveform, reference waveform, logical channel	
	display type	decoded bus, logical signal, bus + logical signal, tabulated list	
	color coding	start of frame, identifier, FD bits, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error	
	data format	hex, decimal, octal, binary, ASCII, symbolic	
	supported data length	64	
Search	source	any input channel or logical channel	
	search event setup	combination of start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) or only symbolic	
	event settings	same as trigger event settings	

R&S®RTP-K11 I/Q software interface

General	function		mixing, filtering, decimbaseband signals as I/	ation and recording of RF or Q samples
	input signals		four real RF signals or two complex I/Q signals or two real RF signals and	
	mixer frequency		one complex I/Q signa between 100 Hz and 2 deactivated)	
	sampling rate of record	ed I/Q samples	,	and 20 Gsample/s user-
	digital filter bandwidth (flat frequency response)	4 % to 80 % of samplir	ng rate
	recording length		max. 40 Msample with	
Trigger	mode		auto or normal	
	operation		triggers on acquired signs serial bus and MSO tri	gnal after A/D conversion gger not available
Display			magnitude of the down	
Amplitude flatness with RF signal input (meas.)	R&S [®] RTP044	max. used center frequency	with I/Q bandwidth 100 MHz	with I/Q bandwidth 500 MHz
3 . (,		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 2 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.4dB	±1.8 dB
	R&S®RTP064	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 2 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 6 GHz	±0.5 dB	±2.0 dB
	R&S®RTP084	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB
	R&S®RTP134	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB
	R&S®RTP164	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB

9 Maximum recording length of 25 Msample for sampling rates of recorded I/Q samples 250 Msample/s to 400 Msample/s.

R&S®RTP-K12 jitter analysis

General description	The R&S®RTP-K12 jitter analysis option extends the functionality of the standard R&S®RTP firmware with a suite of measurement, analysis and visualization tools for signal integrity analysis and jitter characterization.		
Waveform measurements	category	iitter	
	measurement functions	cycle-to-cycle jitter, N-cycle jitter, cycle-to- cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; the standard time measurements period, frequency and setup/hold are also available in the jitter category for convenience	
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source; applicable to time measurements from categories "jitter" and "amplitude and time"; track trace may be used as source for cursor measurements, automatic measurements, math waveforms and reference waveforms	
Waveform math	FFT on track	FFT spectrum of the track trace of measurement results	
	CDR transform	recovers clock timing from source waveform with software CDR and generates synthetic clock waveform that is time-correlated to source	
Software clock data recovery (CDR)	number of CDR instances	up to 2; independently configurable	
,	algorithm	phase-locked loop (PLL), constant frequency	
	configuration	nominal bit rate, PLL order (first or second), PLL loop bandwidth, PLL damping factor, initial phase alignment, result selection during initial synchronization	
Mask testing with eye mask assistant	primary mask shape		
	type	diamond, square, hexagon, octagon	
	dimensions	main and secondary height, main and secondary width, depending on selected shape	
	position	vertical offset, horizontal offset	
	secondary mask shapes		
	locations	any combination of left, right, top, bottom	
	position	horizontal and vertical offset with respect to center of primary mask shape	

R&S®RTP-K19 zone trigger

General description	The R&S®RTP-K19 zone trigger enables the triggering on user-defined zones drawn the display.		
Source		acquired waveforms (input channels), math waveforms	
Zone definition	number of zones	up to 8	
	shapes	rectangles, polygones	
	types	must intersect, must not intersect	
	combination of zones	logical combination of zones of multiple sources using Boolean expressions	
Trigger compatibility		compatible with the trigger modes edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, pattern, state, serial pattern, trigger qualification, and sequence trigger	

R&S®RTP-K21 USB 2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K21 performs USB 2.0 compliance test measurements with R&S®ScopeSuite, including tests for USB 2.0 (high speed), USB 1.1 (full speed) and USB 1.0 (low speed) with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF1 USB 2.0 compliance test fixture set and the Allion USB test fixture solutions and the USB-IF signal quality board device/host; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported USB 2.0 complian	nce tests	
USB device test	high speed	signal quality (EL_2, 4, 5, 6, 7); packet parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18)
	full speed and low speed	full speed signal quality; back voltage; inrush current
USB host test	high speed	signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality downstream; drop; droop
USB hub test	high speed	signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK upstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage

R&S®RTP-K22 Ethernet compliance test (10/100/1000BASE-T)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K22 performs Ethernet compliance test measurements with R&S®ScopeSuite, including tests for 10BASE-T, 100BASE-TX and 1000BASE-T with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the test cases refer to IEEE 802.3-2012.

Supported Ethernet compli	ance tests	
1000BASE-T	with/without disturber	with/without TX_CLK transmitter
		distortion (40.6.1.2.4)
		peak differential output voltage
		(40.6.1.2.1)
		maximum output droop (40.6.1.2.2)
		differential output templates (40.6.1.2.3)
	with TX_CLK	jitter master mode (40.6.1.2.5),
		jitter slave mode (40.6.1.2.5)
	without TX_CLK	jitter master mode (40.6.1.2.5)
	common	MDI return loss (40.8.3.1),
		common mode output voltage (40.8.3.3)
100BASE-TX		amplitude domain tests
		(9.1.2.2, 9.1.3 and 9.1.4)
		rise and fall times (9.1.6)
		peak to peak duty cycle distortion (9.1.8)
		peak to peak transmitter jitter (9.1.9)
		active output interface template (annex J)
		transmitter return loss (9.1.5)
		receiver return loss (9.2.2)
10BASE-T	no TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common mode output voltage
		(14.3.1.2.5)

R&S®RTP-K23 Ethernet compliance test (10GBASE-T)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K23 performs Ethernet compliance test measurements with the R&S®ScopeSuite, including tests for 10GBASE-T with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the test cases refer to IEEE 802.3-2012.

Supported Ethernet compliance tests	
10GBASE-T	maximum output droop (55.5.3.1)
	transmitter linearity (55.5.3.2)
	transmitter timing jitter master mode
	(55.5.3.3)
	transmitter timing jitter slave mode
	(55.5.3.3)
	transmitter power spectral density
	(55.5.3.4)
	transmitter power level (55.5.3.4)
	transmitter clock frequency (55.5.3.5)
	MDI return loss (55.8.2.1)

R&S®RTP-K24 Ethernet compliance test (100BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K24 performs 100BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF2, R&S®RT-ZF7A and R&S®RT-ZF8 Ethernet compliance test fixtures. The chapters after the test cases refer to IEEE 802.3-2018 and OPEN Alliance ECU specification version 2.0.

Supported Ethernet compliance tests	
100BASE-T1	transmitter output droop (96.5.4.1)
	transmitter distortion with and without
	disturber (96.5.4.2)
	transmitter timing jitter master mode
	(96.5.4.3)
	transmitter timing jitter slave mode
	(96.5.4.3)
	transmitter power spectral density
	(96.5.4.4)
	transmitter clock frequency (96.5.4.5)
	transmitter peak differential output
	(96.5.6)
	MDI return loss (96.7.1.3)
	MDI mode conversion loss (96.8.2.2)
	MDI mode conversion loss adapter
	verification (96.8.2.2)
	MDI common mode emission (96.5.1.2)

R&S®RTP-K25 Ethernet compliance test (2.5G/5GBASE-T)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K25 performs 2.5/5G Ethernet compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the test cases refer to IEEE P802.3bz.

Supported Ethernet compliance tests		
2.5G/5GBASE-T	maximum output droop (126.5.3.1)	
	transmitter nonlinear distortion (126.5.3.2)	
	transmitter timing jitter master mode and	
	clock frequency (126.5.3.3 and 126.5.3.5)	
	transmitter timing jitter slave mode	
	(126.5.3.3)	
	transmitter power spectral density and	
	power level (126.5.3.4)	
	MDI return loss (126.6.2.1)	

R&S®RTP-K26 MIPI D-PHY compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K26 performs D-PHY compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V1.1 and V1.2.

Supported D-PHY compliance D-PHY	group 1 (7 tests): data lane LP-TX	data lane LP-TX Thevenin output high
J-FITT	signaling requirements	
	signaling requirements	level voltage (V _{OH}) – 1.1.1
		data lane LP-TX Thevenin output low
		level voltage (V _{OL}) – 1.1.2
		data lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.1.3
		data lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.1.4
		data lane LP-TX slew rate versus C _{LOAD}
		$(\delta V/\delta t_{SR}) - 1.1.5$
		data lane LP-TX pulse width of
		exclusive-OR clock (T _{LP-PULSE-TX}) – 1.1.6
		data lane LP-TX period of exclusive-OR
		clock (T _{LP-PER-TX}) - 1.1.7
	group 2 (5 tests): clock lane LP-TX	clock lane LP-TX Thevenin output high
	signaling requirements	level voltage (V _{OH}) – 1.2.1
	orginaling requirements	clock lane LP-TX Thevenin output low
		level voltage $(V_{OL}) - 1.2.2$
		clock lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.2.3
		clock lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.2.4
		clock lane LP-TX slew rate versus C _{LOAD}
		$(\delta V/\delta t_{SR}) - 1.2.5$
	group 3 (16 tests): data lane HS-TX signaling requirements	data lane HS entry: data lane T _{LPX} value 1.3.1
	3 3 1	data lane HS entry: data lane
		T _{HS-PREPARE} value – 1.3.2
		data lane HS entry: data lane
		T _{HS-PREPARE} + T _{HS-ZERO} value – 1.3.3
		data lane HS-TX differential voltages
		o de la companya de
		$V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$
		data lane HS-TX differential voltage
		mismatch ΔV _{OD} – 1.3.5
		data lane HS-TX single-ended output
		voltages V _{OHHS(DP)} and V _{OHHS(DN)} – 1.3.6
		data lane HS-TX static common mode
		voltages V _{CMTX(1)} and V _{CMTX(0)} – 1.3.7
		data lane HS-TX static common mode
		voltage mismatch ΔV _{CMTX(1.0)} – 1.3.8
		data lane HS-TX dynamic common-leve
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.3.9$
		data lane HS-TX dynamic common-leve
		variations above 450 MHz ΔV _{CMTX(HF)} –
		1.3.10
		data lane HS-TX from 20 % to 80 % rise time $t_R - 1.3.11$
		data lane HS-TX from 80 % to 20 % fall
		time $t_F - 1.3.12$
		data lane HS exit: T _{HS-TRAIL} value – 1.3.1
		data lane HS exit: from 30 % to 85 %
		post-EoT rise time T _{REOT} – 1.3.14
		data lane HS exit: T _{EOT} value – 1.3.15 data lane HS exit: T _{HS-EXIT} value – 1.3.16

D-PHY	group 4 (18 tests): clock lane HS-TX	clock lane HS entry: T _{LPX} value – 1.4.1
	signaling requirements	clock lane HS entry: T _{CLK-PREPARE} value –
	olghamig roquiromonia	1.4.2
		clock lane HS entry:
		T _{CLK-PREPARE} + T _{CLK-ZERO} value – 1.4.3
		clock lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.4.4$
		clock lane HS-TX differential voltage
		mismatch $\Delta V_{OD} - 1.4.5$
		clock lane HS-TX single-ended output
		voltages V _{OHHS(DP)} and V _{OHHS(DN)} – 1.4.6
		clock lane HS-TX static common mode
		voltages V _{CMTX(1)} and V _{CMTX(0)} – 1.4.7
		clock lane HS-TX static common mode
		voltage mismatch ΔV _{CMTX(1,0)} – 1.4.8
		clock lane HS-TX dynamic common-level
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.4.9$
		clock lane HS-TX dynamic common-level
		variations above 450 MHz ΔV _{CMTX(HF)} –
		1.4.10
		clock lane HS-TX from 20 % to 80 % rise
		time t _R – 1.4.11
		clock lane HS-TX from 80 % to 20 % fall
		time t _F – 1.4.12
		clock lane HS exit: T _{CLK-TRAIL} value –
		1.4.13
		clock lane HS exit: from 30 % to 85 %
		post-EoT rise time T _{REOT} – 1.4.14
		clock lane HS exit: T _{EOT} value – 1.4.15
		clock lane HS exit: T _{HS-EXIT} value – 1.4.16
		clock lane HS clock instantaneous: UI _{INST}
		value – 1.4.17
		clock lane HS clock delta UI:
	manus F (C tanta), HC TV alsolves de la	(ΔUI) value – 1.4.18
	group 5 (6 tests): HS-TX clock-to-data	HS entry: T _{CLK-PRE} value – 1.5.1
	lane timing requirements	HS exit: T _{CLK-POST} value – 1.5.2
		HS clock rising edge alignment to first
		payload bit – 1.5.3
		data-to-clock skew (T _{SKEW[TX]}) – 1.5.4
		initial HS skew calibration burst
		T _{SKEWCAL} -SYNC T _{SKEWCAL} - 1.5.5
		periodic HS skew calibration burst
		T _{SKEWCAL-SYNC} T _{SKEWCAL} - 1.5.6

R&S®RTP-K35 bus analysis

General description	The R&S®RTP-K35 bus analysis option functions for dedicated protocols.	The R&S®RTP-K35 bus analysis option adds bus measurements and analysis functions for dedicated protocols.		
	supported protocol options	R&S®RTP-K1 (I ² C, SPI), R&S®RTP-K2 (UART), R&S®RTP-K3 (CAN, LIN), R&S®RTP-K8 (Ethernet), R&S®RTP-K9 (CAN-FD), R&S®RTO-K40 (RFFE), R&S®RTP-K57 (100BASE-T1)		
Measurements	field value	allows the selection of frame types and displays the value of a specified field; the value can be displayed as track and histogram.		
	frame to frame	measures the distance between the starts of two selectable frame types in seconds;		
	trigger to frame	measures the distance between the trigger event and the start of a selectable frame type in seconds; alternatively, measures the distance between the start of a selectable frame type and the trigger event		
	frame count	counts the total number of frames in each acquisition		
	gap time	measures the distance between the end of a selectable frame type to the start of another selectable frame type in seconds		
	bus idle ratio	measures the percentage of idle time on a bus; idle time is defined as the time where the bus is not occupied by frames		
	main bit rate	measures the main bit rate of a protocol based on the relevant bits in a frame; if a protocol provides multiple bit rates, the most relevant bit rate is being measured		
	secondary bit rate	for protocols with multiple bit rates, the secondary bit rate is available		
	frame error count	counts the total number of erroneous frames in each acquisition		
	frame error rate	measures the percentage of erroneous frames in relation to the total frames		
	consecutive frame error rate	measures the percentage of follow up (consecutive) frame errors, ignoring all single frame errors		

R&S®RTP-K37 spectrogram

General description	The R&S®RTP-K37 spectrogram option allows advanced signal analysis in the		
	frequency domain.		
Spectrogram	display characteristics	spectrogram display; a separate spectrogram can be created for each FFT display; each FFT segment of a captured acquisition is displayed in a separate spectrogram line	
		support of logarithmic frequency x-axis	
	number of spectrograms	up to 4	
	signal colors	predefined or user-defined color tables for persistence display with the spectrogram	
	time lines	in stop mode two separate time lines can be used to navigate through a spectrogram in time; for each time line the relevant FFT segment is displayed in a diagram; the difference in acquisition time between the timelines is displayed	
Logarithmic frequency x-axis	display characteristics	logarithmic frequency x-axis for the FFT display with support of analysis tools like cursors and masks	
		logarithmic frequency x-axis for the spectrogram display	
Waveform measurements	measurement functions	total harmonic distortion variants THDa, THDa and THDr using voltage, overall voltage and overall voltage root means square	
	peak list	peak list; diagram labels for easy identification of the peak list entries in the diagram	
Waveform math		user-selectable max. hold and min. hold in addition to spectrum averaging, RMS and envelope	

R&S®RTP-K40 MIPI RFFE serial triggering and decoding

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Protocol configuration	signal type	two channel, single-ended
	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration
	full autoset	full autoset of horizontal and vertical settings and auto threshold setup
	source (SCLK, SDATA)	any two input channels, math waveforms, reference waveforms, or logical channels
	supported version	1.X, 2.0, 2.1 and 3.0
	read mode	standard or sRead mode
	glitch filter	configurable glitch filter
	gap detection	detect gaps between sequences
Trigger	trigger event setup	sequence start, sequence stop, register 0
пуусі	sequence start setup	write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, error condition types 4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of
		range
	sequence stop setup	4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range
	register 0 write setup	4 bit slave address, 7 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options
	register write/read	4 bit slave address, 5 bit register address, 8 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of
	extended register write/read	range for each of these options 4 bit slave address; 8 bit address, byte count: 0 to 15 (inclusive),
		data pattern: 1 to 16 bytes (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 16 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	extended register write long/read long	4 bit slave address, 8 bit address, byte count: 0 to 7 (inclusive), data pattern: 0 to 8 bytes (hex or binary); conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; index: 1 to 8 selects the specific data frame byte; conditions =, ≠, <, ≤, >, ≥, in range
	interrupt summary and notification	4 bit slave address, bit count 0 to 32, notification and interrupt bits
	masked write	4 bit slave address; 8 bit address, 8 bit mask, 8 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥,
	master ownership handover	in range 2 bit MID; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options;
		frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	master write/read	2 bit MID, 8 bit address, 16 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options;
		frame byte; conditions =, \neq , <, \leq , >, \geq , in range

	master context transfer write/read	2 bit MID, 8 bit byte count, 8 bit address, data pattern: 1 to 8 bytes (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 256 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	error condition	SSC error; length error, bus park error, parity error, no response, unknown sequence, version error, min. gap between frames: 1 ns to 10 us
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	sequence, frame, error
	data format	hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits
Search	search event setup	sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, master read, master write, master ownership handover, interrupt summary and notification, error condition types
	event settings	same as trigger event settings

R&S®RTP-K42 MIPI D-PHY serial triggering and decoding

Protocol configuration	signal type	clock, data (differential or single-ended)
	bit rate	selectable without clock lane (1 Mbps to
		2.5 Gbps),
		auto detect with clock lane
	source	any input channels, math waveforms,
		reference waveforms
	variants	D-PHY v. 1.2, CSI-2 v.1.2, DSI v. 1.3
Trigger	trigger event setup	HS start of packet
		HS end of packet
		HS packet header
		HS data
		LP escape mode
		LP lane turnaround
		LP HS request
	HS packet header setup	virtual channel, data type, word count;
	·	conditions =, \neq , <, \leq , >, \geq , in range, out of
		range for data and word count
	HS data	virtual channel, data type, word count,
		data value, data index; conditions =, ≠, <,
		≤, >, ≥, in range, out of range for data
		count, word count, data value
	LP escape mode	escape mode, data value, data index;
	·	conditions =, \neq , <, \leq , >, \geq , in range, out of
		range for escape mode and data value
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	high speed: frames according to trace,
		cells;
		low power: escape word, data word
	data format	hex, octal, binary, , signed, unsigned
	decode layer	off, HS edges, HS binary, HS burst bits,
		HS burst bytes, HS merged bytes, HS
		merged words, LP edges, LP states, LP
		active states, LP binary
Search	search event setup	HS start of packet
		HS end of packet
		HS packet header
		HS data
		LP escape mode
		LP lane turnaround
		LP HS request
	event settings	same as trigger event setup

R&S®RTP-K44 MIPI M-PHY serial triggering and decoding

Protocol configuration	aignal type	up to 4 channels,
Protocol configuration	signal type	differential
	1.00	
	bit rate	clock recovery
	source (SDATA)	analog and math channels,
		reference waveforms
	variants	UniPro 1.6 and M-PHY 4.0
Trigger	trigger event setup	M-PHY burst
		M-PHY adapt
		M-PHY LCC
		UniPro DL_PDU frames
		UniPro PACP frames
		UniPro trigger upper frames
		M-PHY/UniPro errors
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	for different cells/frame types
	data format	K/D symbols; with UniPro additionally:
		hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits, 8b/10b synbols, LCC bits;
		with UniPro additionally: filter/descrambler,
		lane merge, bytes
Search	search event setup	M-PHY burst
		M-PHY adapt
		M-PHY LCC
		UniPro DL PDU frames
		UniPro PACP frames
		UniPro trigger upper frames
		M-PHY/UniPro errors
	I	

R&S®RTP-K50 Manchester and NRZ serial triggering and decoding

Protocol configuration	signal type	selectable,
•		one channel, differential or single-ended,
		two channel, differential or single-ended
	bit rate	auto detected, adjustable
	auto threshold setup	assisted threshold configuration
	source	analog, math. channels, logical (only NRZ)
	bit encoding variants	Manchester,
		Manchester II,
		NRZ clocked,
		NRZ unclocked
	properties	active state (high/low), idle state
		(high/low), clock edge (first/second)
	frame separation	gap, enable signal (only NRZ)
Frame format	frame	multiple frame management,
		frame identification and sync,
		variable length frames,
		variable number of cells
	cells	name, size (bits), numeric format,
		bit order, color
	file storage of frame format	save/load as xml files
Trigger	variants	all supported bit encodings
	trigger event setup	frame start, pattern, advanced trigger
	frame start	gap, start bit
	pattern	up to 256 bit pattern within 65 535 bit frame
	advanced trigger	frame type (with OR combinations), frame
		fields (with AND combinations), frame field
		data; conditions =, \neq , <, \leq , >, \geq , in range,
		out of range for data count, word count,
		data value; error types
Decode	display type	decoded bus, logical signal, bus signal,
		tabulated list, result details, decode layers
	color coding	according to cell configuration table
	data format	according to cell configuration table
	decode layer	edges, binary
Search	event settings	same as advanced trigger settings
Filter	The filter function selects those de	ecode events that shall be shown in the result table.
	Events that do not match the crite	eria set will not be displayed in the table when the filter
	is turned on.	
	settings	same as advanced trigger settings

R&S®RTP-K52 8b10b serial triggering and decoding

Protocol configuration	signal type	one/two channel, differential, single-ended
	bit rate	selectable/adjustable auto configuration,
		ideal for bitrate up to 6.25 Gbit/s
	auto threshold setup	assisted threshold configuration
	one click setup	convenient way for perfect decode results;
		auto scaling of waveforms, auto threshold
		and bitrate estimation on one click
	source (differential, single-ended D+/D-)	full combination of either analog, math, reference channels
	variants	all layer 1 (physical layer) encoded 8b/10b protocols, recommended for Ethernet, FibreChannel 1G, 2G, PCI Express®, Serial ATA, Serial Rapid IO (SRIO), XAUI
Trigger	trigger event setup	symbols, errors
	symbols	K/D symbol (8 bit/10 bit), complex expression (combination of K/D symbols, wildcards, disparity)
	errors	disparity, glitching and unknown symbol
Decode	display type	decoded bus, bus signal, tabulated list, details, decode layers
	color coding	sync symbol, K symbols, data (Dx.y) coding and error coding
	data format	hex, 10 bit and K/D representation
	decode layer	edges, bits
Search	search event setup	symbols, errors
	event settings	same as trigger event settings

R&S®RTP-K55 MDIO serial triggering and decoding

Protocol configuration	bit rate	up to 5 Mbps (auto-detected)
	auto threshold setup	assisted threshold configuration for
		MDIO triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, ST, OP, PHY address, register
	ST setup	address, data 01 (clause 22), 00 clause 45, any
	OP setup	address, write, post read, read, any
	PHY address setup	5 bit address (hex, decimal, octal or
	Pri address setup	binary); equal
	PHY register (clause 22)/device type	5 bit value (hex, decimal, octal or binary);
	(clause 45) setup	equal
	data (clause 22)/data/address (clause 45)	16 bit value (hex, decimal, octal or binary); equal
Decode	source (clock and data)	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, decode layers
	color coding	frame, PHY address, PHY register,
		address, data, turnaround
	PHYAD/PRTAD	symbolic names for user defined addresses
	address/data field format	hex, decimal, octal, binary, ASCII, signed, unsigned
	decode layer	final, edges, binary
Search	source (clock and data)	any input channel, math waveform,
	, ,	reference waveform, logical channel
	search event setup	start, stop, ST, OP, PHY address, register
		address, data
	event settings	same as trigger event settings

R&S®RTP-K57 Ethernet (100BASE-T1) serial triggering and decoding

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Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels single-ended
	symbol rate	66.667 Msymbol/s, adjustable for testing
	thresholds	upper/lower, assisted threshold configuration
	source	any analog input channels, math waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start, MAC frame, idle frame, error conditions
	MAC frame setup	destination address (condition =, \neq , <, >, \geq , \leq , in range, out of range), source address (condition =, \neq , <, >, \geq , \leq , in range, out of range), length/type (condition =, \neq , <, >, \geq , \leq , in range, out of range), frame check (condition =, \neq , <, >, \geq , \leq , in range, out of range), data (condition =, \neq , <, >, \geq , \leq , in range, out of range), data index (condition =, <, >, \geq , \leq , range)
	error condition setup	preamble error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	reversed bits, descrambled bits, scrambled bits, ternary symbols
	accrab avant actum	frame start.
Search	search event setup	MAC frame, idle frame, error conditions

R&S®RTP-K58 Ethernet (1000BASE-T1) serial triggering and decoding

Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels single-ended
	symbol rate	750 Msymbol/s, adjustable for testing
	thresholds	automatically adjusted during decoding
	source	any analog input channels, math
		waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start, MAC frame, idle frame,
		error conditions
	MAC frame setup	destination address (condition =, \neq , <, >, \geq , \leq , in range, out of range), source address (condition =, \neq , <, >, \geq , \leq , in range, out of range), length/type (condition =, \neq , <, >, \geq , \leq , in range, out of range), frame check (condition =, \neq , <, >, \geq , \leq , in range, out of range), data (condition =, \neq , <, >, \geq , \leq , in range, out of range), data index (condition =, <, >, \geq , \leq ,
	error condition setup	range) RS-FEC error, out of range error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	ternary symbols, scrambled bits, descrambled bits, corrected RS-FEC symbols
Search	search event setup	frame start, MAC frame, idle frame, error conditions
	event settings	same as trigger event settings
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R&S®RTP-K60 USB 1.0/1.1/2.0 serial triggering and decoding

Protocol configuration	signal type	single-ended, differential
	protocol type	low, full and high speed
	bit rate	standard bit rates (1.5/12/480 Mbit/s)
	source	any input channel
	probe type	
	for low and full speed	single-ended probe
	for high speed	differential probe (R&S®RT-ZDx)
	auto threshold setup	assisted threshold configuration for USB
		triggering and decoding
Trigger ¹¹	trigger event setup	start of packet, end of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 ¹⁰ , MData ¹⁰), PID handshake (ACK, NAK, STALL, NYET ¹⁰), PID special (PRE ¹¹ , ERR ¹⁰ , SPLIT ¹⁰ , PING ¹⁰); bus state (reset ¹¹ , resume ¹¹ , suspend ¹¹); error condition
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT) 11	condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹¹ and glitching error
Decode	source	any input channel, math waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet identifier, payload length, frame, address, endpoint, data payload, CRC5, CRC16, error condition
	data format	hexadecimal, decimal, octal, binary, ASCII, unsigned
Search	search event setup	combination of start of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 ¹⁰ , MData ¹⁰), PID handshake (ACK, NAK, STALL, NYET ¹⁰), PID special (PRE ¹¹ , ERR ¹⁰ , SPLIT ¹⁰ , PING ¹⁰); error condition (any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹¹ and glitching error)
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT)	condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹¹ and glitching error

¹⁰ Only available in high speed.

¹¹ Only available in low and full speed.

R&S®RTP-K61 USB 3.1 Gen 1 serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	auto threshold setup	supported
	source	any analog input channels, math
		channels, reference channels
	scrambling	selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1,
		TSET2, set link function, U2 inactivity
		timeout, vendor device test, port
		capability, port configuration, port, config.
		resp., link delay meas, ACK, NRDY,
		ERDY, STATUS, STALL, function wake,
		latency tolerance, bus interval, adjust,
		host role request, sublink speed, ping,
		ping response, data packet header, data
		packet payload, DPP aborted,
		isochronous timestamp, link command,
		info, BRST, BDAT, BERC, BCNT, idle;
		fields according to selected USB packet
		with content conditions =, \neq , <, >, \geq , \leq , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	cell and frame types
	data format	hexadecimal, octal, binary, ASCII, signed,
		unsigned, symbols
	decode layer	edges, bits, scrambled symbols,
		descrambled symbols, bytes
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

R&S®RTP-K62 USB 3.1 Gen 2 serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	auto threshold setup	supported
	source	any analog input channels, math
		channels, reference channels
	scrambling	selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1,
		TSET2, set link function, U2 inactivity
		timeout, vendor device test, port
		capability, port configuration, port, config.
		resp., link delay meas, ACK, NRDY,
		ERDY, STATUS, STALL, function wake,
		latency tolerance, bus interval, adjust,
		host role request, sublink speed, ping,
		ping response, data packet header, data
		packet payload, DPP aborted,
		isochronous timestamp, link command,
		info, BRST, BDAT, BERC, BCNT, idle;
		fields according to selected USB packet
		with content conditions =, \neq , <, >, \geq , \leq , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	cell and frame types
	data format	hexadecimal, octal, binary, ASCII, signed,
		unsigned, symbols
	decode layer	edges, bits, scrambled symbols,
0 1		descrambled symbols, bytes
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

R&S®RTP-K63 USB power delivery serial triggering and decoding

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Protocol configuration	signal type	one channel
	bit rate	auto detected
	source	any analog input channel, logical channels, math channels, reference
		channels
	thresholds	data, advertisements
	data details	detailed breakdown selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	extended, NumDataObjs, MsgID,
		PwrRole/Plug, Rev, DataRole, MsgType,
		voltage advertisements (content
		conditions =, \neq , <, >, \geq , \leq , in range, out of
		range)
	errors	4b/5b, preamble, CRC, length,
		SOP warning
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bits, 4b5b symbols
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

R&S®RTP-K64 USB 3.1 SSIC serial triggering and decoding

Protocol configuration	signal type	up to 4 lanes differential
	bit rate	auto detected
	source	any analog input channels, math channels, reference channels
	scrambling	selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout,
		vendor device test, port capability, port
		configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS,
		STALL, function wake, latency tolerance,
		bus interval, adjust, host role request,
		sublink speed, ping, ping response, data
		packet header, data packet payload,
		DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC,
		BCNT, idle;
		fields according to selected USB packet
		with content conditions =, \neq , <, >, \geq , \leq , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits, bytes, 8b/10b symbols, LCC bits, descrambler, lane merge
Search	search event setup	frame start
	·	frame content
		errors
	event settings	same as trigger event settings

R&S®RTP-K65 SpaceWire serial triggering and decoding

Protocol configuration	signal type	two channels: strobe and data (differential or single-ended)
	bit rate	auto adjust (strobe + data)
	source	any analog input channels, logical channels ¹² , math channels, reference channels
	polarity	normal, inverted
Trigger	trigger event setup	control frame, data pattern, null frame, time code, error condition
	control frame setup	any, FCT, EOP, EEP
	data pattern setup	8 bit (condition =, ≠, <, >, ≥, ≤, in range, out of range)
	time code setup	8 bit (condition =, ≠, <, >, ≥, ≤, in range, out of range)
	errors condition setup	parity, ESC
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	control frame, data frame, null frame, time code
	data format	hex
Search	search event setup	control frame, data pattern, null frame, time code, error
	event settings	same as trigger event settings

¹² SpaceWire protocol trigger on logical channels is not available.

R&S®RTP-K72 PCI Express 1.1/2.0 serial triggering and decoding

Protocol configuration	signal type	up to four channels (x1, x2, x4 link size) differential signals
	bit rate	predefined 2.5 Gbit/s for Gen 1 and 5 Gbit/s for Gen 2
	source	any analog input channels, math channels, reference channels
Trigger	trigger event setup	TLP (transaction layer packets), DLLP (data layer packets), ordered sets, errors
	TLP (transaction layer packets)	any type, memory request (32 bit /64 bit, R/W, ordering, snoop, seq. number, Requester ID), I/O transactions, configuration requests, message requests (incl. routing and message code), completion packets (status, completer ID), atomic operation (FetchAdd, SWAP, CAS) for 32 bit/64 bit
	DLLP (data layer packets)	any type, Ack and Nak (seq. number), InitFC1, InitFC2, updateFC (credit type C, NP, Cpl and virtual channel), power management with PM type, vendor packet format. multi-root I/O virtualization (MRDLLP): MRInit (phase, VH FC, mixed type, authorized, device/port type), MRReset (A, VH Group), MRUpdateFC, MRInitFC1 and MRInitFC2 (VL number, VH absent, TLP type, credit type)
	ordered sets	SKP OS, training sequence (TS1, TS2), fast training sequence (FTS), electrical idle OS, electrical idle exit OS, compliance and modified compliance pattern
	errors condition setup	CRC16, ECRC, LCRC, disparity, invalid packets (corrupt header or length errors)
Decode	display type	decoded bus, tabulated list, decode layers, detailed result display for packets
	color coding	TLP, DLLP, K-code, D-code, ordered sets, errors
	data format	K/D symbol, 8 bit format (hex)
	decode layer	8b10b, descrambled 8b10b, bits
Search	search event setup	TLP, DLLP, ordered sets, errors
Ocaron	event settings	same as trigger event settings

R&S®RTP-K81 PCI Express 1.1/2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K81 performs PCle 1.x/2.0 (up to 2.5GT/s) compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the category refer to PCl Express Base Specification Revision 1.1 and 2.1.

Supported PCIe compliance	tests	
PCle 1.1	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage
	reference clock (1.32)	differential input high voltage
		differential input low voltage
		duty cycle
		average clock period
		rising edge rate
		falling edge rate
	common-mode output voltage (4.3.3)	RMS AC peak common mode output
		voltage
		AVG DC common mode output voltage
		DC common mode line delta
		DC common mode output voltage variation
	common-mode input voltage (4.3.3)	AC common mode input voltage
PCle 2.0	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage

R&S®RTP-K83 PCI Express 1.1/2.0/3.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K83 performs PCIe 1.1/2.0/3.0 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported PCIe com	pliance tests	
PCle 1.1	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min. eye width
		median to max. jitter
		differential output voltage
	reference clock (1.32)	differential input high voltage
		differential input low voltage
		duty cycle
		average clock period
		rising edge rate
		falling edge rate
	common mode output voltage (4.3.3)	RMS AC peak common mode output voltage
		AVG DC common mode output voltage
		DC common mode line delta
		DC common mode output voltage variation
	common mode input voltage (4.3.3)	AC common mode input voltage
PCIe 2.0	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage

PCle 3.0	signal quality (4.3.3.13)	mean unit interval
		data rate
		template tests
		min. eye width
	TX base specifications (4.3.3.13.1)	TX voltage with no equalization
		min. swing during electrical idle exit sequence ordered
		set (EIEOS)
		pseudo package loss
		uncorrelated total jitter
		uncorrelated deterministic jitter
		uncorrelated total pulse width jitter
		uncorrelated deterministic pulse width jitter
		data dependent jitter
	reference clock (4.3.8)	REF _{CLK} frequency
		REF _{CLK} jitter
		sSsc frequency range
		ssc deviation
	common-mode output voltage (4.3.3.13)	AC common mode voltage (30 kHz to 500 MHz)
		AC common mode voltage (<4 GHz lowpass filter)
		transmitter avg dc common mode voltage
		DC common mode voltage between d+ and d-
		DC common mode voltage during I0 and electrical idle
	TX equalization presets (4.3.3.5.2)	p0-p10 deemphasis
		p0-p10 preshoot

R&S®RTP-K86 Energy-efficient Ethernet compliance test (10M/100M/1GBASE-T)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K86 performs Energy Efficient Ethernet (EEE) compliance test measurements with R&S®ScopeSuite, including tests for 10BASE-Te, 100BASE-TX EEE and 1000BASE-T EEE with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF4 and R&S®RT-ZF5 Ethernet compliance test fixture set. R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the test cases refer to IEEE 802.3-2012.

Supported EEE compliance test	s	
1000BASE-T EEE		quiet time (78.2)
(requires R&S®RT-ZF5)		refresh time (master) (78.2)
		refresh time (slave) (78.2)
		wake state levels (40.6.1.2.7)
		transmitter timing jitter with TX_TCLK (master) (40.6.1.2.5)
		transmitter timing jitter with TX_TCLK (slave) (40.6.1.2.5)
		transmitter timing jitter without TX_TCLK (master) (40.6.1.2.5)
		transmitter timing jitter without TX_TCLK
		(master) (40.6.1.2.5)
100BASE-TX EEE		sleep time (24.2.3.4 and 78.2)
(requires R&S®RT-ZF5)		LPI quiet time (24.2.3.4 and 78.2)
		LPI refresh time (24.2.3.4 and 78.2)
		LPI transmitter timing jitter (24.2.3.4 and
		78.2)
		transmit wake time (24.2.3.4 and 78.2)
10BASE-Te	no TPM	link test pulse template (14.3.1.2.1)
(requires R&S®RT-ZF4)		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common mode output voltage
		(14.3.1.2.5)

R&S®RTP-K87 Ethernet compliance test (1000BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K87 performs 1000BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF6 frequency converter and R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE 802.3-2018. OPEN Alliance ECU specification supported, where applicable.

Supported 1000BASE-T1 compliance tests		
1000BASE-T1	97.5.3.3 transmitter timing jitter master mode	
	97.5.3.3 transmitter timing jitter slave mode	
	97.5.3.3 transmitter timing MDI jitter	
	97.5.3.6 transmitter clock frequency	
	97.5.3.2 transmitter distortion	
	97.5.3.4 transmitter power spectral density (PSD)	
	97.5.3.4 transmitter power level	
	97.5.3.5 transmitter peak differential output	
	97.5.3.1 maximum output droop	
	97.7.2.1 MDI return loss	
	97.7.2.2 MDI mode conversion loss	
	MDI adapter verification	

R&S®RTP-K88 Ethernet compliance test (MGBASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K88 performs MGBASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3ch.

Supported MGBASE-T1 compliance tests		
MGBASE-T1 (2.5/5/10G)	149.5.2.1 maximum output droop	
	149.5.2.2 transmitter linearity	
	149.5.2.3 transmitter timing jitter master	
	149.5.2.3 transmitter timing jitter slave	
	149.5.2.3.1 transmit MDI random jitter in master mode	
	149.5.2.3.2 transmit MDI deterministic jitter in master mode	
	149.5.2.4 transmitter power spectral density (PSD) and power	
	level	
	149.5.2.5 transmitter peak differential output	
	149.5.2.6 transmitter clock frequency	
	149.8.2.1 MDI return loss	

R&S®RTP-K89 Ethernet compliance test (10BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K89 performs 10BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3cg.

Supported 10BASE-T1 compliance tests		
10BASE-T1S	147.5.4.1 transmitter output voltage	
	147.5.4.3 transmitter timing jitter	
	147.5.4.2 transmitter output droop	
	147.5.4.4 transmitter power spectral density (PSD)	
	147.7.2 MDI return loss	
	147.7.3 MDI mode conversion	
10BASE-T1L	146.5.4.1 transmitter output voltage	
	146.5.4.3 transmitter timing jitter	
	146.5.4.5 transmitter clock frequency	
	146.5.4.4 transmitter power spectral density (PSD) and power	
	level	
	146.8.3 MDI return loss	
	146.8.4 MDI mode conversion	

R&S®RTP-K91 DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K91 performs DDR3 (JESD79-3F), DDR3L(JESD79-3-1A.01) and LPDDR3 (JEDS209-3C) compliance test measurements with R&S®ScopeSuite. Furthermore, it enables the DDR3 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported DDR3 compliance to		
iming tests	clock timing (12.1)	tCK(avg) (12.1.1)
Ü		tCK(abs) (12.1.2)
		tCL(avg) (12.1.3)
		tCH(avg) (12.1.3)
		tJIT(per) (12.1.4)
		tJIT(duty) (12.1.4)
		tJIT(cc) (12.1.5)
	data timing (4.12.2, 12.4, 12.6)	tERR(nper) (12.1.6)
	data timing (4.13.2, 13.4, 13.6)	tDS(base) (13.6) tDH(base) (13.6)
		tDS(derate) (13.6)
		tDH(derate) (13.6)
		tHZ (4.13.2)
		tLZ (4.13.2)
		tDIPW (13.4 note 28)
		tDQSQ (4.13.2)
		tQH (4.13.2)
	strobe timing (4.12, 4.14, 9.3.1)	
	strobe timing (4.13, 4.14, 8.3.1)	tDQSCK (4.13.2)
		tLZ (4.13.2)
		tHZ (4.13.2)
		tRPRE (4.13.2)
		tRPST (4.13.2)
		tQSH (4.13.2)
		tQSL (4.13.2)
		tDQSS (4.14.2)
		tDQSH (4.14.2)
		tDQSL (4.14.2)
		tDSS (4.14.2)
		tDSH (4.14.2)
		tWPST (4.14.2)
		tWPRE (4.14.2)
		tDVAC (strobe) (8.3.1)
		tDVAC (clock) (8.3.1)
	command timing (12.5)	
	command timing (13.5)	tIS (13.5)
		tlS (derated) (13.5)
		tlH (13.5)
		tIH (derated) (13.5)
		tIPW (13.5)
		tVAC (CA) (13.5)
	address timing (13.5) DDR3 and DDR3L	tIS (13.5)
		tIS (derated) (13.5)
		tIH (13.5)
		tIH (derated) (13.5)
		tIPW (13.5)
		tVAC (CA) (13.5)
	address timing (4.2) LPDDR3	tISCA (4.2)
	dudious tilling (4.2) Li DDNo	tlHCA (4.2)
		tlPWCA (4.2)
	although the color (feet and the color of th	tVAC (CA) (13.5)
	chip select timing (13.5) DDR3 and	tlS (13.5)
	DDR3L	tIS (derated) (13.5)
		tIH (13.5)
		tIH (derated) (13.5)
		tIPW (13.5)
	chip select timing (4.2) LPDDR3	tISCS (4.2)
		tlHCS (4.2)
		tIPWCS (4.2)
		tVAC(CS) (11.5)

Electrical tests single-ended	input slew rate for ADD and CMD DDR3	SR(tIS) rising
measurements	and DDR3L (8.5, 13.5) LPDDR3 (7.6,	SR(tIS) falling
measurements	11.5)	SR(tIH) rising
	11.0)	SR(tIH) falling
	input alow rate for DO and DM DDP2 and	SR(tIS) rising
	input slew rate for DQ and DM DDR3 and DDR3L (8.5, 13.6) LPDDR3 (7.6, 11.6)	SR(tIS) falling
		SR(tIH) rising
		SR(tIH) falling
	AC and DC input levels for ADD and	VIH (AC)
	CMD DDR3(8.1.1) DDR3L(3.1)	VIL (AC)
	LPDDR3(7.1.1)	VIH (DC)
		VIL (DC)
	AC input levels for CK and DQS (8.3.3)	VSEH (AC)
		VSEL (AC)
	output slew rate for DQ (9.3)	SRQse rising
		SRQse falling
	AC and DC output levels for DQ (9.2)	VOH(AC)
		VOL(AC)
		VOH(DC)
		VOL(DC)
	AC overshoot and undershoot for ADD	overshoot amplitude
	and CMD (9.6.1)	overshoot area
	aa c (c.c)	undershoot amplitude
		undershoot area
	AC overshoot and undershoot for CK,	overshoot amplitude
	DQ, DQS and DM (9.6.2)	overshoot area
	DQ, DQ3 and DW (9.0.2)	
		undershoot amplitude
Electrical tests differential measurements	AC input levels for CK and DQS (8.3)	undershoot area
Liectifical tests differential measurements	AC input levels for CR and DQ3 (6.3)	VIHdiff (AC)
		\/II 4:tt (\(\Lambda\)C\
	AC differential areas point voltage for CV	VILdiff (AC)
	AC differential cross point voltage for CK (8.4)	VIX (AC)
	differential output slew rate for DQS (9.4)	SRQdiff rising
	ameremial earpareless rate for 2 de (er.)	SRQdiff falling
	differential AC output levels for DQS (9.2)	VOHdiff(AC)
	differential 710 output levels for EQC (5.2)	VOLdiff(AC)
Debug	trigger write cycle	configures the scope to trigger on a write
Dobug	inggor write eyere	cycle
	trigger read cycle	configures the scope to trigger on a read
	trigger read cycle	cycle
DDR3 decoding		Cycle
<u> </u>	signal type	DO DOS
Protocol configuration	signal type	DQ, DQS
	bit rate	adjustable
	threshold setup	manual threshold/hysteresis configuration
Decede	source	analog channels
Decode	display type	decoded bus, tabulated list, details
	color coding	read frame, write frame
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bits, words
Search	search event setup	frame content, error
	frame content	data; conditions =, \neq , <, \leq , >, \geq , in range, out of range

DDR3 eye diagram			
General description	The DDR3 eye diagram allows the user to generate eye diagrams from long multi- period acquisitions of clock signals and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions.		
General configuration	number of eye diagram instances main source	up to 4; independently configurable analog channels, math channels, reference channels	
	timing reference source	analog channels, math channels, reference channels	
	horizontal settings	range, position; expressed in absolute time or relative to user-defined bit rate	
Display	persistence	50 ms to 50 s, or infinite	
	trace colors	predefined or user-defined color tables	
	eye stripe	displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled.	
Qualification	gate		
	position	start, stop; absolute time or relative to display in percent	
	coupling	none, cursor #, zoom #	
	signal		
	source	analog channels, math channels, reference channels	
	condition	greater than, less than; relative to selected reference level	
Filter	DDR3 protocol		
	frame type	any, read frame, write frame	
	error	length	
	bit sequence		
	mode	all, level transition, constant level, bit pattern	
	bit pattern setup	up to 8 prefix bits and up to 5 suffix bits with respect to central eye diagram bit	
Mask testing	mask test results		
-	counters	acquisitions, slices, sample hits, slice hits, fail rate	
	violation details	number and position of mask violation, expressed as time instant and slice index	
	navigation and zoom	use zoom coupling to navigate to violation upon clicking the corresponding table item	

R&S®RTP-K93 DDR4/LPDDR4 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K93 performs DDR4 (JESD79-4B), LPDDR4 (JESD209-4B) and LPDDR4X(JESD209-4-1) compliance test measurements with R&S®ScopeSuite. Furthermore, it enables the DDR4 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S®ScopeSuite supports Windows 7, 8 and 10.

Timing tests	clock timing (13.3)	tCK(abs) (13.3.1)
-	,	tCK(avg) (13.3.2)
		tCL(avg) (13.3.3)
		tCH(avg) (13.3.3)
		tJIT(per) (13.3.4)
		tJIT(duty) (13.3.4)
		tJIT(cc) (13.3.4)
		tERR(nper) (13.3.4)
	data timing (4.24.1.2, 4.24.1.3)	tDQSQ (4.24.1.2)
	,	tQH (4.24.1.2)
		tLZ(DQ) (4.24.1.3)
		tHZ(DQ) (4.24.1.3)
	strobe timing (8.3.1, 4.24.1, 4.25.1)	tDVAC(Strobe) (8.3.1)
		tDVAC(Clock) (8.3.1)
		tLZ(DQS) (4.24.1)
		tHZ(DQS (4.24.1)
		tDQSCK (4.24.1)
		tRPRE (4.24.1)
		tRPST (4.24.1)
		tQSH (4.24.1)
		tQSL (4.24.1)
		tDQSS (4.25.1)
		tDQSH (4.25.1)
		tDQSL (4.25.1)
		tDSS (4.25.1)
		tDSH (4.25.1)
		tWPRE (4.25.1)
	command timing (13.7)	tIS(base) (13.7)
		tIH(base) (13.7)
		tIPW (13.7)
	address timing (13.7)	tIS(base) (13.7)
		tlH(base) (13.7)
		tIPW (13.7)
	chip select timing (13.7)	tlS(base) (13.7)
		tlH(base) (13.7)
		tIPW (13.7)

Electrical tests single-ended measurements	AC and DC input levels for ADD and CMD (8.1)	VIH(AC)
measurements	(6.1)	\/II (AC)
		VIL(AC)
		VIH(DC)
		VIL(DC)
	AC input levels for CK (8.3.3)	VSEH(AC)
		VSEL(AC)
	AC overshoot and undershoot for ADD,	VAOSP
	CMD (8.3.4)	VAOS
		VAUS
		AAOS2
		AAOS1
		AAUS
	AC overshoot and undershoot for CK	VCOSP
	(8.3.5)	VCOS
	,	VCUS
		ACOS2
		ACOS1
		ACUS
	AC overshoot and undershoot for DQ,	VDOSP
	DQS and DM (8.3.6)	VDUS
		VDUS
		VDUSP
		ADOS2
		ADOS1
		ADUS1
		ADUS2
	input slew rate for ADD and CMD (8.4.2)	SR(tIS) rising
		SR(tIS) falling
		SR(tIH) rising
		SR(tIH) falling
	AC & DC output levels for DQ (9.2)	VOH(AC)
	(0.2)	VOL(AC)
		VOH(DC)
		VOL(DC)
	output slew rate for DQ (9.4)	SRQse rising
	output siew rate for DQ (9.4)	SRQse falling
Electrical tests differential measurements	AC and DC input levels for CK (8.3.2)	
Electrical tests differential measurements		VIHdiff(AC)
		VILdiff(AC)
		VIHdiff(DC)
		VILdiff(DC)
	input slew rate for CK (8.4.1)	SRdiff rising
		SRdiff falling
	differential cross point voltage for CK (8.5)	VIX(CK)
	AC input levels for DQS (8.7.2)	VIHDiffPeak
		VILDiffPeak
	input slew rate for DQS (8.7.5)	SRdiff rising
		SRdiff falling
	differential AC output levels for DQS (9.3)	VOHdiff(AC)
	. , ,	VOLdiff(AC)
	differential output slew rate for DQS (9.5)	SRQdiff rising
	, , , , , , , , , , , , , , , , , , , ,	SQQdiff falling
DDR4 decoding		
Protocol configuration	signal type	DQ, DQS
	bit rate	adjustable
	threshold setup	manual threshold/hysteresis configuration
	source	analog channels
Decode	display type	decoded bus, tabulated list, details
200000	color coding	read frame, write frame
	·	
	data format	hex, octal, binary, signed, unsigned
Occasili	decode layer	edges, bits, words
Search	search event setup	frame content, error
	frame content	data; conditions =, \neq , <, \leq , >, \geq , in range,
		out of range
	error	length, frame incomplete

DDR4 eye diagram General description	The DDR4 eve diagram allows the use	r to generate eve diagrams from long multi-		
Oeneral description	The DDR4 eye diagram allows the user to generate eye diagrams from long period acquisitions of clock signals and serial data signals. It allows the fine of the signal content that contributes to the eye diagram and enables the advantance analysis, measurement, mask test and navigation functions.			
General configuration	number of eye diagram instances	up to 4; independently configurable		
•	main source	analog channels, math channels, reference channels		
	timing reference source	analog channels, math channels, reference channels		
	horizontal settings	range, position; expressed in absolute time or relative to user-defined bit rate		
Display	persistence	50 ms to 50 s, or infinite		
	trace colors	predefined or user-defined color tables		
	eye stripe	displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled		
Qualification	gate			
	position	start, stop; absolute time or relative to display in percent		
	coupling	none, cursor #, zoom #		
	signal			
	source	analog channels, math channels, reference channels		
	condition	greater than, less than; relative to selected reference level		
Filter	DDR4 protocol			
	frame type	any, read frame, non-consecutive read frame, write frame, non-consecutive write frame		
	error	length		
	bit sequence			
	mode	all, level transition, constant level, bit pattern		
	bit pattern setup	up to 8 prefix bits and up to 5 suffix bits with respect to central eye diagram bit		
Mask testing	mask test results			
	counters	acquisitions, slices, sample hits, slice hits fail rate		
	violation details	number and position of mask violation, expressed as time instant and slice index		
	navigation and zoom	use zoom coupling to navigate to violation upon clicking the corresponding table item		

R&S®RTP-K99 R&S®ScopeSuite automation

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. It requires matching compliance test options (see below). R&S®RTP-K99 makes it possible to automate the supported compliance options remotely. After remote execution of a test case the user can collect the results to process them in a proprietary software to create own reports.

Remote API to execute test cases of R&S®ScopeSuite		
API language		C#
Supported options	R&S®RTP-K22	100BASE-TX, 1000BASE-T
	R&S®RTP-K24	100BASE-T1
	R&S®RTP-K87	1000BASE-T1
	R&S®RTP-K91	DDR3, DDR3L, LPDDR3
	R&S®RTP-K93	DDR4, LPDDR4, LPDDR4X

R&S®RTP-K101 USB 3.2 transmitter compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K101 performs USB 2.0/3.2 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported USB 3.2 compliand USB 2.0 device test	high speed	signal quality (EL_2, 4, 5, 6, 7); packet
USB 2.0 device lest	nigri speed	parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18)
	full speed and low speed	full speed signal quality; back voltage; inrush current
USB 2.0 host test	high speed	signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality downstream; drop; droop
USB 2.0 hub test	high speed	signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK upstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage
USB 3.2 device test	SuperSpeed (Gen 1)	TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye TD 1.3: short channel transmitted eye TD 1.6: SSC profile
	SuperSpeedPlus (Gen 2)	TD 1.4: long channel transmitted eye TD 1.4: short channel transmitted eye TD 1.5: transmit equalization TD 1.7: SSC profile
USB 3.2 host test	SuperSpeed (Gen 1)	TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye TD 1.3: short channel transmitted eye TD 1.6: SSC profile
	SuperSpeedPlus (Gen 2)	TD 1.4: long channel transmitted eye TD 1.4: short channel transmitted eye TD 1.5: transmit equalization TD 1.7: SSC profile

USB 3.2 hub test	SuperSpeed (Gen 1)	TD 1.1: upstream low frequency periodic signaling TX; TD 1.3: upstream long channel transmitted eye TD 1.3: upstream short channel transmitted eye TD 1.6: upstream SSC profile TD 1.1: downstream low frequency periodic signaling TX; TD 1.3: downstream long channel transmitted eye TD 1.3: downstream short channel transmitted eye
	SuperSpeedPlus (Gen 2)	TD 1.6: downstream SSC profile TD 1.4: upstream long channel transmitted eye TD 1.4: upstream short channel transmitted eye TD 1.5: upstream transmit equalization TD 1.7: upstream SSC profile TD 1.4: downstream long channel transmitted eye TD 1.4: downstream short channel transmitted eye TD 1.5: downstream transmit equalization TD 1.7: downstream SSC profile

R&S®RTP-K121 deembedding base option

General description	The R&S®RTP-K121 deembedding base option allows waveform correction based on S-parameters of the involved measurement blocks. The correction parameters of a		
	cable or a modified probe can also be determined by using proven cable/proven probe.		
Source	channel 1, channel 2, channel 3,		
	channel 4,		
Signal types	single-ended signals		
	differential signals based on two separate		
	cables by using two channels		
	full differential signals based on		
	differential probes		
S-parameter files	s2p-files and s4p-files		
Types of blocks	cables, connectors, fixtures and customer		
• •	defined blocks		
Maximum number of blocks	10		

Proven cable/proven probe

General description	Proven probe/cable is a part of the R&S®RTP-K121 deembedding base option. This		
	function enables the user to determine the correction parameters of a cable or a		
	modified probe based on the R&S®RTP-B7 differential pulse source.		
Mode		proven cable	
		proven probe (Rohde & Schwarz probes	
		user defined)	
Configurations	proven cable	single ended	
	proven probe	single ended, differential	
Correction method	cable, user defined probe	transmission (magnitude and phase)	
	Rohde & Schwarz probe	transmission (magnitude and phase)	
Maximal group delay of DUT		20 ns	
Maximal length of cables (setup)		3 m	
Source	step with amplitude of -200 mV		

R&S®RTP-K122 realtime deembedding extension

General description	The R&S®RTP-K122 realtime deembedding extension option allows waveform	
	correction based on S-parameters in realtime. This option is an extension to the	
	R&S®RTP-K121 deembedding base option. For details, see R&S®RTP-K121 option.	
Realtime waveform acquisition rate	see acquisition system	

R&S®RTP-K130 TDR/TDT analysis

General description	The R&S®RTP-K130 TDR/TDT option is a measurement technique used to determine			
		the characteristics of electrical lines by observing reflected and/or transmitted waveforms. Together, they provide a powerful means of analyzing electrical		
	transmission media.			
Mode		TDR, TDT, TDR/TDT		
Configuration		single ended, full differential		
Signals		impedance/reflection coefficient		
Domain		time/distance		
Bandwidth	TDR and/or TDT, single ended			
	R&S®RTP044	4 GHz		
	R&S®RTP064	6 GHz		
	R&S®RTP084	8 GHz		
	R&S®RTP134	13 GHz		
	R&S®RTP164	16 GHz		
	TDR or TDT, differential			
	R&S®RTP044	4 GHz		
	R&S®RTP064	6 GHz		
	R&S®RTP084	8 GHz		
	R&S®RTP134	13 GHz		
	R&S®RTP164	16 GHz		
	TDR and TDT, differential			
	R&S®RTP044	4 GHz		
	R&S®RTP064	6 GHz		
	R&S®RTP084	8 GHz		
	R&S®RTP134	8 GHz		
	R&S®RTP164	8 GHz		
Step amplitude		200 mV		
Repetition rate		50 Hz to 500 kHz		
		(depends on horizontal scale)		
Length of cable	max.	15 ns (\sim 3.2 m at ε_r = 2)		
Č	min.	2 ns (\sim 0.4 m at ε_r = 2)		
Electrical length of short	range, adjustable by user	0 ns to 2 ns		
Reference impedance	single ended	50 Ω		
	differential	100 Ω		

R&S®RTP-K133 advanced jitter analysis

General description		The R&S®RTP-K133 option provides advanced jitter measurements and enables jitter separation. R&S®RTP-K133 option includes R&S®RTP-K12 option.		
Jitter separation	total jitter (TJ),	400 1.400 1.111 1.112 optionii		
sitter coparation	deterministic jitter (DJ),			
	data dependent jitter (DDJ),			
	periodic jitter (PJ),			
		DD I+B I)		
	random jitter (RJ),	data dependent jitter plus periodic jitter (DDJ+PJ),		
		111)		
	(other) bounded uncorrelated jitter ((O)BUJ), random jitter plus (other) bounded uncorrelated jitter (RJ+(O)BUJ)			
Accepted input signals	clock signals or data signals (NRZ)	related filter (No 1(O)DOO)		
Reference clock	internal clock recovery (PLL first or seco	nd order constant clock or food forward)		
Vereience clock	or explicit clock signal	nd order, constant clock or leed forward)		
Dania manauramanta	·	^t		
Basic measurements	symbol rate, symbol duration, event cour			
Jitter measurements	total jitter at bit error rate (TJ@BER)	value in seconds or unit interval BER value selectable		
		between 10 ⁻³² and 10 ⁻¹		
	dotorministic litter (D.L. duel direct			
	deterministic jitter (DJ, dual-dirac)	value in seconds or unit interval		
	duty cycle distortion (DCD)	value in seconds or unit interval		
	inter symbol interference (ISI)	value in seconds or unit interval		
	total jitter (TJ) corresponds to	peak-to-peak value and RMS value in		
	time interval error (TIE)	seconds or unit interval		
	deterministic jitter (DJ)	peak-to-peak value and RMS value in		
		seconds or unit interval		
	data dependent jitter (DDJ)	peak-to-peak value and RMS value in		
		seconds or unit interval		
	periodic jitter (PJ)	peak-to-peak value and RMS value in		
		seconds or unit interval		
	data dependent jitter plus periodic jitter	peak-to-peak value and RMS value in		
	(DDJ+PJ)	seconds or unit interval		
	periodic jitter components	amplitude, frequency,		
		direction (vertical or horizontal)		
	random jitter (RJ)	RMS value in seconds or unit interval		
	(other) bounded uncorrelated jitter	peak-to-peak value and RMS value in		
	((O)BUJ)	seconds or unit interval		
	(other) bounded uncorrelated jitter ((O)BUJ, dual-dirac)	value in seconds or unit interval		
	random jitter plus (other) bounded	peak-to-peak value and RMS value in		
	uncorrelated jitter (RJ+(O)BUJ)	seconds or unit interval		
Statistics	max. and min. values for each jitter mea	max. and min. values for each jitter measurement type		
litter result plots	histogram (rising edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
-	histogram (falling edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
	histogram (both edges)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
	TIE track	TJ, DDJ, PJ, RJ+OBUJ		
	power spectral density (PSD)	TJ, DDJ, PJ, RJ+OBUJ		
Additional result plots	step response	1 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7		
	bathtub	PJ and (O)BUJ removable from noise		
		bathtub		
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P		

R&S®RTP-K134 advanced jitter and noise analysis

One and decodation	The DOORDTD KAOA and have side and have	and the same and a street section and		
General description	The R&S®RTP-K134 option provides advanced jitter and noise measurements and separation. R&S®RTP-K134 option includes R&S®RTP-K133 advanced jitter analysis			
	· ·	•		
Noise congration		option and R&S®RTP-K12 basic jitter analysis option.		
Noise separation	total noise (TN),			
	deterministic noise (DN),			
	data dependent noise (DDN),			
	periodic noise (PN),	(DDM : DM)		
	data dependent noise plus periodic noise	(DDN+PN),		
	random noise (RN),	IN IV		
	(other) bounded uncorrelated noise ((OBU	, ·		
	random noise plus other (other) bounded u	uncorrelated hoise (RN+(O)BUN)		
Accepted input signals	clock signals or data signals (NRZ)			
Reference clock	internal clock recovery (PLL first or second or explicit clock signal	d order, constant clock or feed forward)		
Basic measurements	symbol rate, symbol duration, event count			
Noise measurements	eye height at bit error rate (EN@BER)	absolute or relative,		
		BER value selectable		
		between 10 ⁻³² and 10 ⁻¹		
	level distortion (LD)	absolute or relative value		
	inter symbol interference noise (ISIN)	absolute or relative value		
	total noise (TN)	peak-to-peak value and RMS value,		
		absolute or relative		
	deterministic noise (DN)	peak-to-peak value and RMS value,		
		absolute or relative		
	data dependent noise (DDN)	peak-to-peak value and RMS value,		
		absolute or relative		
	periodic noise (PN)	peak-to-peak value and RMS value,		
		absolute or relative		
	data dependent noise plus periodic noise	peak-to-peak value and RMS value,		
	(DDN+PN)	absolute or relative		
	periodic noise components	amplitude, frequency,		
		direction (vertical or horizontal)		
	random noise (RN)	RMS value, absolute or relative		
	(other) bounded uncorrelated noise	peak-to-peak value and RMS value,		
	((O)BUN)	absolute or relative		
	(other) bounded uncorrelated noise ((O)BUN, dual-dirac),	absolute or relative value		
	random noise plus (other) bounded	peak-to-peak value and RMS value,		
	uncorrelated noise (RJ+(O)BUN)	absolute or relative		
Statistics	max. and min. values for each noise meas			
Noise result plots	histogram (level 0)	TN, DN, DDN, PN, RN+OBUN		
•	histogram (level 1)	TN, DN, DDN, PN, RN+OBUN		
	histogram (both levels)	TN, DN, DDN, PN, RN+OBUN		
	TIE track	TN, DDN, PN, RN+OBUN		
	power spectral density (PSD)	TN, DDN, PN, RN+OBUN		
Additional result plots	step responses			
	noise bathtub	PN and (O)BUN removable from noise		
		bathtub		
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P		

R&S®RTP-K140 high speed serial pattern trigger (8 Gbps)

General description	The R&S®RTP-K140 high speed serial pattern trigger option provides triggering functions for simple or complex combinations of bit patterns or 8b10b words up to			
Source	rate of 8 Gbps including clock da	ata recovery. any analog channel		
Source	clock	any analog channel or extracted from data channel by using a clock data recovery		
Trigger types	single bit pattern	up to 160 bit; wildcards supported		
	dual bit pattern	two bit patterns with 160 bit each connected with logical OR; wildcards supported		
	complex word pattern	frame alignment by bit pattern of up to 32 bit or timeout; up to 4 bit patterns (up to 160 bit in total) connected with logical AND or OR; conditions: =, ≠, <, >, ≥, ≤, i range, out of range; bit offset, length and search range definable for each pattern		
	8b10b	aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error		
	PRBS error	locks to PRBS sequences of type 7, 9, 11, 15, 16, 17, 20, 23, 29, 31 and triggers on error		
Clock data recovery	bit rate	21 kbps to 8 Gbps; supports bit rate estimation		
	unit interval position	0 to 1		

R&S®RTP-K141 high speed serial pattern trigger (16 Gbps)

General description	The R&S®RTP-K141 high speed serial pattern trigger option provides triggering			
	functions for simple or complex combinations of bit patterns or 8b10b words up to a bit rate of 16 Gbps including clock data recovery.			
Source	data	any analog channel		
	clock	any analog channel or extracted from data channel by using a clock data recovery		
Trigger types	single bit pattern	up to 160 bit; wildcards supported		
	dual bit pattern	two bit patterns with 160 bit each connected with logical OR; wildcards supported		
	complex word pattern	frame alignment by bit pattern of up to 32 bit or timeout; up to 4 bit patterns (up to 160 bit in total) connected with logical AND or OR; conditions: =, ≠, <, >, ≥, ≤, ir range, out of range; bit offset, length and search range definable for each pattern		
	8b10b	aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error		
	PRBS error	locks to PRBS sequences of type 7, 9, 1 15, 16, 17, 20, 23, 29, 31 and triggers or error		
	128b132b	aligns on selectable word; triggers on selectable word		
Clock data recovery	bit rate	21 kbps to 16 Gbps; supports bit rate estimation		
	unit interval position	0 to 1		

Ordering information

Designation	Туре	Order No.
Base unit (including standard accessories: R&S®RT-ZA16 precision BNC to SN		uick start guide, power cord
High-performance oscilloscope	1 (1 // 1	<i>y</i> , ,
4 GHz, 50 Msample memory	R&S®RTP044	1320.5007.04
6 GHz, 50 Msample memory	R&S®RTP064	1320.5007.06
8 GHz, 50 Msample memory	R&S®RTP084	1320.5007.08
13 GHz, 50 Msample memory	R&S®RTP134	1320.5007.13
16 GHz, 50 Msample memory	R&S®RTP164	1320.5007.16
Hardware options (plug-in)	1100 111 104	1320.3007.10
	R&S®RTP-B1	1222 2424 02
Mixed signal option, 400 MHz	R&S®RTP-B1E	1333.2424.02 1337.9581.02
Digital extension port for R&S®RT-ZVC usage with R&S®RTP oscilloscope, included in R&S®RTP-B1	R&S°RTP-BTE	1337.9581.02
	DA ORDED DO	4000 0440 00
Arbitrary waveform generator, 100 MHz, 2 analog channels, 8-bit pattern	R&S®RTP-B6	1333.2418.02
generator	D00@DTD D7	1000 0001 00
16 GHz differential pulse source	R&S®RTP-B7	1333.2001.02
Adapter rear option slot	R&S®RTP-B21	1338.0507.02
Additional solid state disk	R&S®RTP-B19	1337.9498.02
Memory upgrade, 100 Msample per channel	R&S®RTP-B101	1337.9500.02
Memory upgrade, 200 Msample per channel	R&S®RTP-B102	1337.9517.02
Memory upgrade, 500 Msample per channel	R&S®RTP-B105	1337.9523.02
Memory upgrade, 1 Gsample per channel	R&S®RTP-B110	1337.9530.02
Bandwidth upgrades 13		
Upgrade of the R&S®RTP044 to 6 GHz bandwidth	R&S®RTP-B0406	1337.9398.02
Upgrade of the R&S®RTP044 to 8 GHz bandwidth	R&S®RTP-B0408	1337.9400.02
Upgrade of the R&S®RTP044 to 13 GHz bandwidth	R&S®RTP-B0413	1801.3707.02
Upgrade of the R&S®RTP044 to 16 GHz bandwidth	R&S®RTP-B0416	1801.3713.02
Upgrade of the R&S®RTP064 to 8 GHz bandwidth	R&S®RTP-B0608	1337.9430.02
Upgrade of the R&S®RTP064 to 13 GHz bandwidth	R&S®RTP-B0613	1801.3720.02
Upgrade of the R&S®RTP064 to 16 GHz bandwidth	R&S®RTP-B0616	1801.3736.02
Upgrade of the R&S®RTP084 to 13 GHz bandwidth	R&S®RTP-B0813	1801.3742.02
Upgrade of the R&S®RTP084 to 16 GHz bandwidth	R&S®RTP-B0816	1801.3759.02
Upgrade of the R&S®RTP134 to 16 GHz bandwidth	R&S®RTP-B1316	1801.3765.02
Software options	Kas KIF-DISIO	1601.3765.02
Serial triggering and decoding	D 0 0 0 D T D 1/4	4007.0004.00
12C/SPI serial triggering and decoding	R&S®RTP-K1	1337.8604.02
UART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTP-K2	1337.8610.02
CAN/LIN serial triggering and decoding	R&S®RTP-K3	1337.8627.02
MIL-STD-1553 serial triggering and decoding	R&S®RTP-K6	1800.6654.02
ARINC 429 serial triggering and decoding	R&S®RTP-K7	1800.6660.02
Ethernet (10BASE-T/100BASE-Tx) serial triggering and decoding	R&S®RTP-K8	1337.8633.02
CAN-FD serial triggering and decoding	R&S®RTP-K9	1337.8640.02
MIPI RFFE serial triggering and decoding	R&S®RTP-K40	1337.8733.02
MIPI D-PHY serial triggering and decoding	R&S®RTP-K42	1337.8740.02
MIPI M-PHY serial triggering and decoding	R&S®RTP-K44	1337.8756.02
Manchester and NRZ serial triggering and decoding	R&S®RTP-K50	1337.8762.02
8b10b serial triggering and decoding	R&S®RTP-K52	1337.8779.02
MDIO serial triggering and decoding	R&S®RTP-K55	1337.8785.02
Ethernet (100BASE-T1) serial triggering and decoding	R&S®RTP-K57	1800.6548.02
Ethernet (1000BASE-T1) serial triggering and decoding	R&S®RTP-K58	1800.6702.02
USB 1.0/1.1/2.0 serial triggering and decoding	R&S®RTP-K60	1337.8791.02
USB 3.1 Gen 1 serial triggering and decoding	R&S®RTP-K61	1337.8804.02
USB 3.1 Gen 2 serial triggering and decoding	R&S®RTP-K62	1337.9100.02
	R&S®RTP-K63	
USB power delivery serial triggering and decoding		1337.8810.02
USB 3.1 SSIC serial triggering and decoding	R&S®RTP-K64	1337.9117.02
SpaceWire serial triggering and decoding	R&S®RTP-K65	1800.6677.02
PCI Express 1.1/2.0 serial triggering and decoding	R&S®RTP-K72	1337.8827.02

¹³ The bandwidth upgrade is performed at a Rohde & Schwarz service center, where the oscilloscope will also be calibrated.

Designation Compliance tests	Туре	Order No.
USB 2.0 compliance test	R&S®RTP-K21	1337.8685.02
Ethernet compliance test (10/100/1000BASE-T)	R&S®RTP-K22	1337.8691.02
Ethernet compliance test (10GBASE-T)	R&S®RTP-K23	1337.8704.02
Ethernet compliance test (100BASE-T1)	R&S®RTP-K24	1800.6531.02
Ethernet compliance test (2.5G/5G-BASE-T)	R&S®RTP-K25	1337.8710.02
MIPI-D-PHY compliance test	R&S®RTP-K26	1337.8727.02
PCI Express 1.1/2.0 compliance test	R&S®RTP-K81	1337.8885.02
PCI Express 1.1/2.0/3.0 compliance test	R&S®RTP-K83	1800.6954.02
Energy-efficient Ethernet compliance test (10M/100M/1G-BASE-T)	R&S®RTP-K86	1337.8833.02
Ethernet compliance test (1000BASE-T1)	R&S®RTP-K87	1800.6554.02
Ethernet compliance test (MGBASE-T1)	R&S®RTP-K88	1800.6725.02
Ethernet compliance test (10BASE-T1)	R&S®RTP-K89	1800.6719.02
DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test	R&S®RTP-K91	1337.8840.02
DDR4/LPDDR4 signal integrity debug and compliance test	R&S®RTP-K93	1801.3671.02
R&S®ScopeSuite automation	R&S®RTP-K99	1326.4425.02
USB 3.2 transmitter compliance test	R&S®RTP-K101	1800.6948.02
Analysis	Nao IVII IVIOI	1000.0040.02
I/Q software interface	R&S®RTP-K11	1800.6683.02
Jitter analysis	R&S®RTP-K12	1337.8656.02
Zone trigger	R&S®RTP-K19	1337.8879.02
Bus analysis	R&S®RTP-K35	1800.6648.02
Spectrogram	R&S®RTP-K37	1338.1110.02
Deembedding base option	R&S®RTP-K121	1326.3064.02
Realtime deembedding extension	R&S®RTP-K121	1326.3070.02
TDR/TDT analysis	R&S®RTP-K130	1326.3093.02
Advanced jitter analysis	R&S®RTP-K133	1800.6860.02
Advanced jitter and noise analysis	R&S®RTP-K134	1800.6977.02
	R&S®RTP-K134	
High speed serial pattern trigger (8 Gbps)	R&S®RTP-K140	1326.4554.02
High speed serial pattern trigger (16 Gbps) Probes	R&5°R1P-K141	1326.4560.02
	D 0 C®DT 7700	4.400.7000.00
8.0 GHz transmission line probe, 10:1, 500 Ω, 0.3 pF, 20 V (RMS)	R&S®RT-ZZ80	1409.7608.02
3.0 GHz active voltage probe, single-ended, 1 MΩ, 0.8 pF	R&S®RT-ZS30	1410.4309.02
6.0 GHz active voltage probe, single-ended, 1 MΩ, 0.3 pF	R&S®RT-ZS60	1418.7307.02
4.0 GHz power rail probe, 1:1, low noise, 50 kΩ, large offset range ±60 V	R&S®RT-ZPR40	1800.5406.02
1.0 GHz active voltage probe, differential, 1 MΩ, 0.6 pF, incl. R&S®RT-ZA15	R&S®RT-ZD10	1410.4715.02
1.5 GHz active voltage probe, differential, 1 MΩ, 0.6 pF	R&S®RT-ZD20	1410.4409.02
3.0 GHz active voltage probe, differential, 1 MΩ, 0.6 pF	R&S®RT-ZD30	1410.4609.02
4.5 GHz active voltage probe, differential, 1 MΩ, 0.4 pF	R&S®RT-ZD40	1410.5205.02
6.0 GHz modular probe amplifier, differential, 400 kΩ, multimode	R&S®RT-ZM60	1419.3105.02
9.0 GHz modular probe amplifier, differential, 400 kΩ, multimode	R&S®RT-ZM90	1419.3205.02
Tip cable, solder in, length: 15 cm, multimode compatible	R&S®RT-ZMA10	1419.4301.02
Tip cable, square pin, for 1.27 mm pin header, length: 15 cm, multimode	R&S®RT-ZMA12	1419.4324.02
compatible		
Tip cable, quick connect, for solder in resistor connection, length: 15 cm,	R&S®RT-ZMA15	1419.4224.02
multimode		
Browser module, variable span from 0.5 mm to 8 mm, spring-loaded, multimode	R&S®RT-ZMA30	1419.4353.02
SMA module, 2.92 mm/3.5 mm/SMA, differential, 100 Ω, DC termination,	R&S®RT-ZMA40	1419.4201.02
multimode		
Extended temperature kit, 1 m matched cable pair, multimode compatible	R&S®RT-ZMA50	1419.4218.02
Multi-channel power probe, 2 x 4 voltage/current channels	R&S®RT-ZVC04	1326.0259.04
Multi-channel power probe, 2 x 2 voltage/current channels	R&S®RT-ZVC02	1326.0259.02
Probe set for E and H near-field measurements, 9 kHz to 1 GHz	R&S®HZ-14	1026.7744.03
Power supply, required for usage of R&S®HZ-14 near-field probe	R&S®HZ-9	0816.1015.03
Compact probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
3 GHz, 20 dB preamplifier, 100 V to 230 V power adapter, for R&S®HZ-15	R&S®HZ-16	1147.2720.02
Probe accessories		
High-impedance buffer amplifier, incl. 500 MHz passive probe	R&S®RT-Z1M	1337.9200.02
Spare accessory set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA2	1416.0405.02
Pin set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA3	1416.0411.02
Mini clips	R&S®RT-ZA4	1416.0428.02
Micro clips	R&S®RT-ZA5	1416.0434.02
Lead set	R&S®RT-ZA6	1416.0440.02
Pin set for R&S®RT-ZD20/30	R&S®RT-ZA7	1417.0609.02

Designation	Туре	Order No.
Probe box to N/USB adapter	R&S®RT-ZA9	1417.0909.02
External attenuator, 10:1, 2.0 GHz, 70 V DC, 46 V AC (peak)	R&S®RT-ZA15	1410.4744.02
Power rail browser kit	R&S®RT-ZA25	1800.5329.00
Pigtail cable, solder-in, length: 15 cm, for R&S®RT-ZPR20	R&S®RT-ZA26	1800.5258.00
3D probe positioner	R&S®RT-ZAP	1326.3641.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA30	1333.1686.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA31	1333.1692.02
Oscilloscope interface cable for R&S®RT-ZVC (included in R&S®RT-ZVC02/-ZVC04, 1326.0259.02/.04)	R&S®RT-ZA33	1333.1770.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA34	1333.1892.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA35	1333.1905.02
Solder-in cable set for R&S®RT-ZVC, 4 current and voltage solder-in cables, solder-in pins	R&S®RT-ZA36	1333.1911.02
Extended cable set for R&S®RT-ZVC, BNC connector, 1 current and voltage lead, length: 16 cm	R&S®RT-ZA37	1337.9130.02
Accessories		
Precision BNC to SMA adapter	R&S®RT-ZA16	1320.7074.02
Front cover, for R&S®RTP oscilloscopes	R&S®RTP-Z1	1337.9569.02
Front handles, for R&S®RTP oscilloscopes	R&S®RTP-B20	1338.0688.02
Transit case, for R&S®RTP oscilloscopes	R&S®RTP-Z4	1337.9575.02
Travel hard case, for R&S®RTP oscilloscopes and accessories	R&S®RTP-Z6	1338.0865.02
USB 2.0 compliance test fixture set	R&S®RT-ZF1	1317.3420.02
Ethernet compliance test fixture set	R&S®RT-ZF2	1317.5522.02
Frequency converter (100BASE-T1)	R&S®RT-ZF3	5025.0670.02
Ethernet 10BASE-Te fixture	R&S®RT-ZF4	1333.0915.02
Ethernet probe fixture	R&S®RT-ZF5	1333.0938.02
Frequency converter (1000BASE-T1)	R&S®RT-ZF6	1337.8579.02
Automotive Ethernet T&D fixture	R&S®RT-ZF7	1801.3688.02
SMA adapter	R&S®RT-ZF7A	1801.4126.02
Automotive Ethernet compliance fixture	R&S®RT-ZF8	1801.3694.02
Probe deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
Probe test fixture	R&S®RT-ZF30	1333.2099.02
19" rackmount kit, for R&S®RTP oscilloscopes with 6 HU	R&S®ZZA-KN6	1175.3056.00

Version 12.00, April 2021

Warranty		
Base unit		3 years
All other items ¹⁴		1 year
Options		
Extended warranty, one year	R&S®WE1	Please contact your local
Extended warranty, two years	R&S®WE2	Rohde & Schwarz sales
Extended warranty with calibration coverage, one year	R&S®CW1	office.
Extended warranty with calibration coverage, two years	R&S®CW2	
Extended warranty with accredited calibration coverage, one year	R&S®AW1	
Extended warranty with accredited calibration coverage, two years	R&S®AW2	

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge 15. Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs 15 and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs 15 and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

¹⁴ For options that are installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

¹⁵ Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

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- ➤ Worldwide

- Local and personalized
 Customized and flexible
 Uncompromising quality
 Long-term dependability

Rohde & Schwarz

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